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# A Programmable Frequency Divider Having a Wide Division Ratio Range, and Close-to-50\% Output Duty-Cycle 

Mo Zhang<br>University of Tennessee - Knoxville

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To the Graduate Council:
I am submitting herewith a dissertation written by Mo Zhang entitled "A Programmable Frequency Divider Having a Wide Division Ratio Range, and Close-to-50\% Output Duty-Cycle." I have examined the final electronic copy of this dissertation for form and content and recommend that it be accepted in partial fulfillment of the requirements for the degree of Doctor of Philosophy, with a major in Electrical Engineering.

Syed Kamrul Islam, Major Professor

We have read this dissertation and recommend its acceptance:
Benjamin J. Blalock, Charles L. Britton, Jr., Xiaobing Feng
Accepted for the Council:
Carolyn R. Hodges
Vice Provost and Dean of the Graduate School
(Original signatures are on file with official student records.)

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A Dissertation
Presented for the Doctor of Philosophy Degree

The University of Tennessee, Knoxville

Mo Zhang
May, 2007

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#### Abstract

In Radio Frequency (RF) integrated circuit design field, programmable dividers are getting more and more attentions in recent years. A programmable frequency divider can divide an input frequency by programmable ratios [1]. It is a key component of a frequency synthesizer. It also can be used to generate variable clock-signals for: switched-capacitor filters (SCFs), digital systems with different power-states, as well as multiple clock-signals on the same system-on-a-chip (SOC). These circuits need high performance programmable frequency dividers, operating at high frequencies and having wide division ratio ranges, with binary division ratio controls and $50 \%$ output duty-cycle.

Different types of programmable frequency dividers are reviewed and compared. A programmable frequency divider with a wide division ratio range of $(8 \sim 524287)$ has been reported [2]. Because the output duty-cycle of this reported divider is far from $50 \%$, the circuit in [2] has very limited applications. The proposed design solves this problem, without compromising other advantages of the design in [2]. The proposed design is fabricated in a $0.18-\mu \mathrm{m}$ RF CMOS process. Test results show that the output duty-cycle is $50 \%$ when the division ratio is an even number. The duty-cycle is $44.4 \%$ when the division ratio is 9 . The output duty-cycle becomes closer to $50 \%$ when the division ratio is an increasing odd number. For each division ratio, the output duty-cycle remains constant, with different input frequencies from GHz down to kHz ranges, with different


temperatures and power supply voltages. This thesis provides an explanation of the design details and test results.

A Phase Locked-Loop (PLL) based frequency synthesizer can generate different output frequencies. A programmable frequency divider is an important component of this type of PLL. Since bandwidth is expensive, it is preferred to reduce the frequency channel distance of a frequency synthesizer. Using a fractional programmable divider, the frequency channel distance of a PLL can be reduced, without reducing the reference frequency or increasing the settling time of the PLL. A frequency synthesizer with a programmable fractional divider is designed and fabricated. A brief description of the PLL design and test results are presented in this dissertation.

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## Chapter 1

## Introduction

A frequency divider can divide the input frequency $f_{\text {in }}$ to a lower frequency $f_{\text {out }}=f_{\text {in }} / \mathrm{N}$ as shown in Figure 1 (a). There are frequency dividers with a single fixed division ratio and programmable division ratios as shown in Figure 1 (b). A fixed ratio divider can be used in a PLL with a fixed output frequency. The division ratio N of a programmable frequency divider can be varied. By changing the division ratio, a programmable frequency divider could generate different output frequencies.

Programmable frequency dividers are getting more and more attention in recent years. A programmable frequency divider is an important component of a frequency synthesizer, or a PLL with variable output frequencies. When used in a frequency synthesizer, normally the output duty-cycle of the programmable frequency divider need not be close to $50 \%$. The reason is that the Phase/Frequency Detector (PFD) in a PLL is mostly single-edge triggered.

Also, a programmable frequency divider can be used to generate variable clock-signals to drive various types of clocked circuits. When used to drive clocked circuits, the output duty-cycle of a programmable frequency divider should be close to $50 \%$ for better performance. Clocked circuits include switched-capacitor filters (SCFs), digital systems

(a)

(b)

Figure 1: Fundamentals of frequency dividers: (a) function of a frequency divider, and (b) classification of frequency dividers


Figure 2: An application of switched-capacitor filters (SCFs): (a) the corner frequency of a SCF could be adjusted by changing the clock frequency, and (b) SCFs could be used in equalizers for audio systems.
with different power-states, as well as multiple clock-signals on the same system-on-achip (SOC), and so on.

Figure 2 shows an application of SCFs. Figure 2 (a) shows the transfer function of a lowpass SCF. The corner frequency of the SCF could be varied by changing the clock frequency, which is used to drive the SCF. Also, there are SCFs used as band-pass filters, high-pass filters, and notch (band-reject) filters. The corner frequencies of these SCFs could also be adjusted by changing the clock frequencies. SCFs can be used in audio systems, such as equalizers shown in Figure 2 (b). Equalizers can adjust the output power at different frequency bands. SCFs need clock signals (up to several hundred MHz) with variable frequencies to adjust the corner frequencies. The variable clock signals can be generated using a programmable frequency-divider. The duty-cycle of the clock signal should be as close to $50 \%$ as possible for proper operation of the SCFs.

Figure 3 shows an example of the clock and power control of digital systems. Digital systems can use different power states to save power. When the intensity of tasks is lower, low power states could be used. Different power states can use different operating frequencies generated from a programmable frequency divider to adjust the power consumption. Lower operating frequencies can reduce the power consumption. A $50 \%$ duty-cycle is important to give equal settling time to circuits when the clock signal is high or low.

Figure 4 shows that the system-on-a-chip (SOC) needs multiple clock signals in a wide frequency range. A PLL followed by several programmable frequency dividers can generate different variable clock signals in a wide frequency range in a SOC. All the digital circuits will have better performance when the duty-cycle of the clock signals is closer to $50 \%$.

These circuits need high performance programmable frequency dividers, operating at high frequencies and having wide division ratio ranges, binary division ratio controls and $50 \%$ output duty-cycle. However, before this research work, none of the reported dividers meet all the desirable characteristics. The proposed design is aimed to generate a programmable frequency divider with all the above features.


Figure 3: Clock and power control of digital systems.


Figure 4: System-on-a-chip (SOC) needs multiple clock signals in a wide frequency range [3].

## Chapter 2

## Problem Statements

Various types of circuits need a high performance programmable frequency-divider. Previous designs have some of the following limitations:

- The output duty-cycle is far from $50 \%$,
- Poor capability to drive clocked circuits,
- Requirements of complicated control circuits,
- Operating frequency range is limited,
- Division ratio range is limited.

The proposed work is aimed to create a divider without the above limitations.

### 2.1 Previous Programmable Divider Designs (Prior Art)

Table 1 lists almost all the high frequency CMOS programmable frequency-dividers that have a wide division ratio range $\left(\mathrm{n}_{\max } / \mathrm{n}_{\min }\right.$ is $>2$, where $\mathrm{n}_{\max }$ is the maximum division ratio, and $\mathrm{n}_{\min }$ is the minimum division ratio), that have been reported. A few papers that repeated the same type dividers are not listed for simplicity. If $\mathrm{n}_{\max } / \mathrm{n}_{\min }$ is $\leq 2$, the output frequency range is quite limited. For example, if the highest output frequency is 100 MHz , the lowest output frequency will not be lower than 50 MHz . While if the division ratio range is $2^{\min } \sim 2^{\max +1}-1$, and if the highest output frequency is 100 MHz , the lowest output frequency can be in the range of $\mathrm{MHz}, \mathrm{kHz}$ or even lower. A programmable

Table 1: Literature review of the published programmable frequency dividers.

|  | Authors | Publish Year | Division ratio range | $\begin{gathered} \text { Process } \\ (\mu \mathrm{m}) \end{gathered}$ | Wide division ratio range | Wide <br> $f_{\text {in }}$ range | High operatingfrequency | Binary control | Close to 50\% output dutycycle |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Proposed design |  | $\begin{gathered} 2^{\min }---2^{\max +1}- \\ 1 \\ \hline \end{gathered}$ | $\begin{aligned} & \mathrm{CMOS} \\ & 0.18 \mu \mathrm{~m} \end{aligned}$ | $\sqrt{ }$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |
| $[2]$ | C.S.Vaucher et al. | 2000 | $\begin{aligned} & 2^{\min }--2^{\max +1}- \\ & 1(8-262143) \end{aligned}$ | $\begin{aligned} & \mathrm{CMOS} \\ & 0.35 \mu \mathrm{~m} \end{aligned}$ | $\checkmark$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |  |
| [4] | X.P. Yu et al. | 2005 | N $\times$ P + S | $\begin{array}{\|l\|} \hline \mathrm{CMOS} \\ 0.18 \mu \mathrm{~m} \end{array}$ | $\checkmark$ | $\checkmark$ | $\checkmark$ |  | $\checkmark$ |
| [5] | S. Khadanga et al. | 2003 | $\begin{gathered} \mathrm{P} \times \mathrm{R}+\mathrm{S} \\ (9--65024) \end{gathered}$ | $\begin{array}{\|l\|} \hline \mathrm{CMOS} \\ 0.18 \mu \mathrm{~m} \\ \hline \end{array}$ | $\checkmark$ | $\checkmark$ |  |  |  |
| [6] | D. <br> Guermandi et al. | 2002 | $\begin{gathered} 2(\mathrm{P} 1 \times 4+\mathrm{P} 2 \times 5) \\ (98-4608) \end{gathered}$ | $\begin{aligned} & \mathrm{CMOS} \\ & 0.35 \mu \mathrm{~m} \end{aligned}$ | $\sqrt{ }$ | $\checkmark$ | $\checkmark$ |  |  |
| [7] | T. Ohgishi et al. | 1978 | $\mathrm{P} \times \mathrm{R}+\mathrm{S}$ | $4 \mu \mathrm{~m}$ | $\checkmark$ | $\checkmark$ |  |  |  |
| [8] | Lee SangHoon et al. | 2002 | $2--2^{M}-1$ | $\begin{aligned} & \mathrm{CMOS} \\ & 0.6 \mu \mathrm{~m} \end{aligned}$ | $\sqrt{ }$ | $\checkmark$ |  | $\checkmark$ |  |
| [9] | Chang HunHsien et al. | 1998 | $2--2^{\mathrm{M}}-1$ | $\begin{aligned} & \mathrm{CMOS} \\ & 0.8 \mu \mathrm{~m} \end{aligned}$ | $\checkmark$ | $\sqrt{ }$ |  | $\sqrt{ }$ |  |

frequency-divider with a wide output frequency range can have much more applications. For example, it can offer clock signals for several digital circuits which need different clock frequencies on the same chip and for switched capacitor circuits which need clock signals with a wide adjustable frequency range.

It can be seen that there are only 3 types of high-frequency CMOS programmable frequency-dividers with a wide division ratio range. The first type is a counter, as shown in references [8] and [9]. A counter has a wide division ratio range from 2 to $2^{\mathrm{M}}-1$, where M is the number of "divide-by-2 Counter" stages. The top-level schematic is shown in Figure 5. The operating frequency for this type divider is limited by the accumulated delay time of all the M counter stages. This can be seen from Figure 5 (b), since the logic combination of " $\mathrm{Q}_{1} \ldots \mathrm{Q}_{6}$ ", the output signals from all the counter stages, determines the "Reload" signal. The "Reload" signal resets all the counter stages at the same time to start a new counting cycle. Because of the accumulated delay time, it is difficult for the operating frequency of a counter to reach a high value.

The second type programmable-divider is the " $\mathrm{P} \times \mathrm{R}+\mathrm{S}$ " divider, as shown in Figure 6. Its operating-speed is comparable with the circuit created by C. S. Vaucher et al. [2]. The division ratio control, $\mathrm{P} \times \mathrm{R}+\mathrm{S}$, is not directly in a binary format. In order to be implemented in the actual digital circuits, this second type divider needs extra encoder to transfer the binary control-signals to the $\mathrm{P} \times \mathrm{R}+\mathrm{S}$ format. (Reference [2] already has binary control as shown in equation (1)). Binary numbers can be easily implemented in the

(a)

(b)

Figure 5: Schematics of a previously reported programmable counter [9]: (a) the toplevel block diagram, and (b) the end-of-count (EOC) detector.


Figure 6: The block diagram of a previously reported programmable divider with division ratios $\mathrm{N} \times \mathrm{P}+\mathrm{S}$ [4].
actual circuits, since "LOW" and "HIGH" are used to represent " 0 " and " 1 " in digital circuits. C. S. Vaucher et al. [2] reported a programmable frequency-divider with a very wide division ratio range, $\left(2^{\min } \sim 2^{\max +1}-1\right)$. The number " $m i n$ " and " $m a x$ " can be controlled independently. The schematics of the design [2] are shown in Figure 7. The design is comprised of cascade stages of " $2 / 3$ cell". " $2 / 3$ cell" is a divider with division ratios of 2 or 3 .

The design [2] has several advantages: (1) a wide division ratio range for the circuit in Figure 7 (b), (2) high operating-frequencies, since its operating-frequency is not limited by the delay of all the stages, (3) easy to redesign with different number of stages, since each stage has the similar structure, and (4) the division ratio controls are in a binary format as shown in the following equation. According to [2], the division ratio for the circuit shown in Figure 7 (a) is,

$$
\begin{equation*}
\text { division ratio }=P_{0} \cdot 2^{0}+P_{1} \cdot 2^{1}+P_{2} \cdot 2^{2}+\cdots+P_{n-1} \cdot 2^{n-1}+2^{n} \tag{1}
\end{equation*}
$$

where $\mathrm{P}_{0}, \mathrm{P}_{1}, \ldots, \mathrm{P}_{\mathrm{n}-1}$ are the control bits of the division ratio. Their logic levels are ' 0 ' or '1'.

Compared with the other published programmable dividers, the divider [2] has more attractive characteristics. It still has a shortcoming that its output duty-cycle is far from $50 \%$. It is difficult to use the design [2] for various applications, which need a close-to$50 \%$ clock duty-cycle. The simulation in Figure 8 demonstrates this problem. In the simulation shown in Figure $8, f_{\text {in }}=5 \mathrm{GHz}$, and the signal " $\bmod _{1}$ " is used as the output

(a)

(b)

Figure 7: A published programmable frequency divider [2]: (a) the block diagram of the basic architecture ( $2^{\mathrm{n}} \leq \mathrm{N} \leq 2^{\mathrm{n}+1}-1$ ), where N is the division ratio, and (b) the circuit diagram with extended division range $\left(2^{\min } \leq \mathrm{N} \leq 2^{\max +1}-1\right)$, (in this figure $\max =\mathrm{n}, \min =$ $\mathrm{n}-2$ ).


Figure 8: The duty-cycle problem with the published design [2]. The signal " $\bmod _{1}$ " is used as the output signal of the divider. In this simulation, $f_{\text {in }}=5 \mathrm{GHz}$.
signal of the divider. The pulse width of " $\bmod _{1}$ " is in the nanosecond range. It is difficult to drive load capacitors by using this signal. Even inside a chip, parasitic capacitances also exist, which can become load capacitors.

The capacitors connected to "mod " terminal may not be able to be charged to the expected voltage during the narrow pulses. The goal of the proposed design is to solve this problem, while maintaining other advantages of the existing circuit [2].

### 2.2 Problem Definition

C. S. Vaucher et al. designed a programmable frequency divider with high operating frequency and with a wide range of division ratios $\left(2^{\min } \sim 2^{\max +1}-1\right)$ [2]. The designer can specify the minimum power value "min" and the maximum power value "max". Thus the output frequency can be changed widely, such as 100 MHz to 1 MHz , and to 1 kHz . The circuit in [2] also can use binary controls to set the division ratios as shown in (1).

Vacucher's divider [2] has a disadvantage that its output pulse width is only 2 or 3 times of the input period. If the input frequency is 2 GHz , the output pulse width is only 1 ns or 1.5 ns , as shown in Figure 9. The output pulse width does not change if the output frequency is lower. It is difficult to drive large clocked systems by using these narrow pulses, since the divider may not be able to charge the load capacitors to the correct logic level of the clock signal. For example, if the capacitor load is 10 pF , and the supply voltage is 2 V , in order to charge the capacitor from 0 V to 2 V in 1 ns , the driving


Figure 9: Vaucher's design [2] has low capability to drive other circuits.
current should be,

$$
\begin{equation*}
2 V \times 10 \mathrm{pF} / 1 \mathrm{~ns}=20 \mathrm{~mA} \tag{2}
\end{equation*}
$$

If the driving current is not large enough, the clocked circuits will not read the logic " 1 " part of the clock signal. If the duty-cycle is close to $50 \%$, with the same output frequency, the output pulse width will be much longer. Having the same current at the output stage, the driving capability of the divider will be greatly increased.

From another point of view, a clock signal with close to $50 \%$ duty-cycle can also increase the maximum operating-frequency of clocked circuits. For example, in a master-slave D-Flip-Flop (DFF) as shown in Figure 10, when the "CLK" signal is low, the master circuit is operating; but when "CLK" is high, the slave circuit is operating. As shown in Figure 11 (d), signals in digital circuits require time $\mathrm{t}_{\text {required }}$ to charge the load capacitors to the desired logic level, and to settle down from the oscillation. A master-slave DFF should have equal settling time when the "clock" signal is high or low. To operate at high frequencies, the duty-cycle of the clock signal should be $50 \%$ to give enough time to both the master and the slave circuits to settle down.


Figure 10: A standard master-slave D-Flip-Flop.


Figure 11: The maximum operating frequency of a master-slave DFF vs. duty-cycle of the clock signal.

The following derivations give a more accurate relationship between the maximum operating frequency of a master-slave DFF and the duty-cycle of the clock signal. The definition of duty-cycle for a periodic signal is,

$$
\begin{equation*}
\text { duty }- \text { cycle }=\frac{\mathrm{t}_{\text {high }}}{\mathrm{T}} \tag{3}
\end{equation*}
$$

where T is the period, and $\mathrm{t}_{\text {high }}$ is the time when the signal is logic high. As shown in Figure 11 (a),

$$
\begin{equation*}
\mathrm{t}_{\text {short }}=\operatorname{minimum}\left(\mathrm{t}_{\text {high }}, \mathrm{t}_{\text {low }}\right) \tag{4}
\end{equation*}
$$

If duty-cycle $\leq 50 \%, t_{\text {short }}=t_{\text {high }}$. From equation (3), the duty-cycle should be,

$$
\begin{equation*}
\text { duty }- \text { cycle }=\frac{\mathrm{t}_{\text {short }}}{\mathrm{T}} \tag{5}
\end{equation*}
$$

The following result could be obtained.

$$
\begin{equation*}
\mathrm{T}=\frac{\mathrm{t}_{\text {short }}}{\text { duty }- \text { cycle }} \tag{6}
\end{equation*}
$$

If assume $t_{\text {required }}$ is the time needed to charge the load capacitors, and to settle the oscillations, the relationship $t_{\text {short }} \geq t_{\text {required }}$ should exist. Thus,

$$
\begin{gather*}
\mathrm{T}=\frac{\mathrm{t}_{\text {short }}}{\text { duty }- \text { cycle }} \geq \frac{\mathrm{t}_{\text {required }}}{\text { duty }- \text { cycle }}  \tag{7}\\
f=\frac{1}{\mathrm{~T}} \leq \frac{\text { duty }- \text { cycle }}{\mathrm{t}_{\text {required }}} \tag{8}
\end{gather*}
$$

The maximum operating frequency, $f_{\max }$, will be equal to,

$$
\begin{equation*}
f_{\max }=\frac{\text { duty }- \text { cycle }}{\mathrm{t}_{\text {required }}} \propto \text { duty }- \text { cycle } \tag{9}
\end{equation*}
$$

The left part of Figure 11 (c) shows the relationship in equation (9).

As shown in Figure 11 (b), if duty-cycle $\geq 50 \%, \mathrm{t}_{\text {short }}=\mathrm{t}_{\text {low }}$. Thus,

$$
\begin{equation*}
\text { duty }- \text { cycle }=\frac{t_{\text {high }}}{T}=\frac{T-t_{\text {low }}}{T}=\frac{T-t_{\text {short }}}{T}=1-\frac{t_{\text {short }}}{T} \tag{10}
\end{equation*}
$$

By switching "duty - cycle" and " $\frac{\mathrm{t}_{\text {short }}}{\mathrm{T}}$ " in the above equation, the following result can be obtained.

$$
\begin{gather*}
1-\text { "duty - cycle" }=\frac{\mathrm{t}_{\text {short }}}{\mathrm{T}}  \tag{11}\\
\text { Thus } T=\frac{\mathrm{t}_{\text {short }}}{1-\text { "duty - cycle" }} \geq \frac{\mathrm{t}_{\text {required }}}{1-\text { "duty - cycle" }}  \tag{12}\\
\text { and } f=\frac{1}{\mathrm{~T}} \leq \frac{1-\text { "duty }- \text { cycle" }}{\mathrm{t}_{\text {required }}} \tag{13}
\end{gather*}
$$

The maximum operating frequency, $f_{\max }$, will be equal to,

$$
\begin{equation*}
f_{\max }=\frac{1-\text { "duty }- \text { cycle" }}{\mathrm{t}_{\text {required }}} \tag{14}
\end{equation*}
$$

The right part of Figure 11 (c) shows the relationship in equation (14).

Figure 11 (c) shows that when the duty-cycle of the clock signal is $50 \%$, the Master-slave DFF can achieve the highest operating frequency. Similarly, clock signals with $50 \%$ duty-cycle will also optimize the maximum operating frequency of other clocked circuits.

The output duty-cycle of Vaucher's divider [2] is far from $50 \%$, which can be expressed as,

$$
\text { Duty cycle of previous design }=\left\{\begin{array}{l}
\frac{2}{n}, \text { when } n \text { is an even number }  \tag{15}\\
\frac{3}{n}, \text { when } n \text { is an odd number }
\end{array}\right.
$$

where n is the division ratio.

The output duty-cycle of [2] is $<10 \%$, when n is $>20$ and n is an even number. For larger values of $n$, the duty-cycle becomes smaller. For example, if $n=10000$, duty-cycle $=0.02 \%$. The small output duty-cycles will degrade the performance of clocked circuits, or digital systems. A thorough review of relevant literatures indicates that no duty-cycle corrector has been reported for the input duty-cycles less than $2 \%$ [10] - [17]. The reported duty-cycle correctors could not resolve the duty-cycle problem in [2] when its output duty-cycle is less than $2 \%$.

The proposed design solved the problem of Vaucher's design [2], without degrading its other advantages. The output duty-cycle of the proposed design is very close to $50 \%$ (within $44.4 \% \sim 50 \%$ ). For each division ratio, the output duty-cycle remains constant, with different input frequencies from GHz down to kHz range, at different temperatures and with different power supply voltages. Test results corroborate the efficacy of the proposed design.

### 2.3 Original Contributions

The achievement of the dissertation includes:

- The output signal of the proposed work has close to $50 \%$ duty-cycle (the dutycycle error is $\leq 5.6 \%$ )
- The step-size of the division ratios is kept to be 1 .
- The output duty-cycle remains constant with PVT (Process-Voltage-Temperature) changes and input frequency variations $(\mathrm{GHz}-\mathrm{kHz})$.
- A smaller layout area, because of the elimination of large resistors.
- Derivation of the expression for the programmable division ratio.


### 2.3.1 Close to 50\% Output Duty-Cycle

The circuit in [2] has a disadvantage that the output duty-cycle is far off the desired goal of $50 \%$. Its output duty-cycle is: $2 / \mathrm{n}$ when n is an even number, or $3 / \mathrm{n}$ when n is an odd number, where n is the division ratio. The output waveform and duty-cycle of the circuit [2] is shown in Figure 12 (a). It limits the applications of the programmable divider. The proposed method can make the output duty-cycle of the programmable divider [2] very close to $50 \%$ (the duty-cycle error $=\mid 50 \%$-"duty-cycle" $\mid \leq 5.6 \%$ ), and keep the step of division ratio to be 1 . The output waveform and duty-cycle of the proposed design is shown in Figure 12 (b). The output duty-cycle of the proposed design can be expressed as,

$$
\text { Duty cycle }=\left\{\begin{array}{l}
50 \%  \tag{16}\\
\frac{k}{2 k+1},
\end{array} \quad \text { when divided by an even number }, ~ \text { whided by an odd number } 2 k+1\right.
$$



Output signal of previous design

(a) The maximum output duty-cycle of the previous work is $35 \%$, which goes down with larger division ratios.


Output signal of proposed design

(b) The minimum output duty-cycle of the proposed design is about $45 \%$.

Figure 12: Comparison of the output duty-cycle of: (a) the prior art [2], and (b) the proposed design.

Since k is $\geq 4$ (the minimum division ratio of the proposed design is 8 ), the duty-cycle error is $\leq 5.6 \%$. When the division ratio is $>50$, the duty-cycle error is $<1 \%$. A few possible applications of the proposed programmable frequency divider with close to $50 \%$ output duty-cycle are described in the following sections.

### 2.3.1.1 Switched-Capacitor Filters

Switched-capacitor filters (SCFs) are widely used in audio systems, since they have advantages such as high accuracy and that varying the clock frequency can change the corner frequencies of SCFs [18]. Some SCFs need high-frequencies clock signals such as 160 MHz [19]. If the proposed wide division-ratio divider follows a PLL output signal to generate the clock frequencies for the SCFs, the corner frequencies of the SCFs can be varied widely from several hundred MHz to arbitrary low frequencies. SCFs need equal and adequate time to settle when the clock signal is high or low. Thus the duty-cycle of the clock signal for a SCF should be as close to $50 \%$ as possible. Otherwise, there could be significant problems such as signal distortion, inaccurate filter response and signal attenuation [21].

Figure 13 shows that a switched capacitor can be viewed as an equivalent resistor. A switched capacitor (Figure 13 (b)) needs non-overlapping clock signals $\Phi_{1}$ and $\Phi_{2}$ (Figure 13 (c)), which can come from the output of a programmable divider. In Figure 13 (b), $\mathrm{M}_{1}$ and $\mathrm{M}_{2}$ are connected to $\Phi_{1}$, and $\mathrm{M}_{3}$ and $\mathrm{M}_{4}$ are connected to $\Phi_{2}$. When $\Phi_{1}$ is high (Figure $13(\mathrm{~d})$ ), a charge $Q=\left(V_{1}-V_{2}\right) C$ will flow from node $\mathrm{V}_{1}$ to $\mathrm{V}_{2}$. When $\Phi_{2}$ is high

(a)


T is the period of the clock signal
(c)

$\Phi_{1}$ is high, $\mathrm{M}_{1}$ and $\mathrm{M}_{2}$ are turned on

$\Phi_{2}$ is high, $\mathrm{M}_{3}$ and $\mathrm{M}_{4}$ are turned on
(e)

$$
\overline{\mathrm{I}}=\mathrm{Q} / \mathrm{T}=\mathrm{Q} \times \mathrm{f}_{\mathrm{Clk}}=\left(\mathrm{V}_{1}-\mathrm{V}_{2}\right) \mathrm{C} \times \mathrm{f}_{\mathrm{Clk}} \quad \mathrm{R}=\frac{\mathrm{V}_{1}-\mathrm{V}_{2}}{\mathrm{I}}
$$

Figure 13: A switched capacitor viewed as a resistor: (a) the equivalent resistor, (b) a switched capacitor, (c) the non-overlapping clock signal for the switched capacitor, (d) when $\Phi_{1}$ is high, and (e) when $\Phi_{2}$ is high.


Figure 14: The principle of a switched capacitor filter (low-pass).
(Figure 13 (e)), no charge will flow from node $\mathrm{V}_{1}$ to $\mathrm{V}_{2}$, but C will be discharged through $M_{3}$ and $M_{4}$. During a full clock period, the average current flowing from $V_{1}$ to $V_{2}$ is,

$$
\begin{equation*}
\bar{I}=\frac{Q}{T_{c l k}}=Q \cdot f_{c l k}=\left(V_{1}-V_{2}\right) C \cdot f_{c l k} \tag{17}
\end{equation*}
$$

The equivalent resistor will be,

$$
\begin{equation*}
R=\frac{V_{1}-V_{2}}{\bar{I}}=\frac{V_{1}-V_{2}}{\left(V_{1}-V_{2}\right) C \cdot f_{c l k}}=\frac{1}{C \cdot f_{c l k}} \tag{18}
\end{equation*}
$$

Figure 14 shows an example of a switched capacitor filter, whose corner frequency can be varied by the clock frequency. $\mathrm{R}_{2}$ and $\mathrm{R}_{3}$ are the equivalent resistances of the switch capacitors $C_{2}$ and $C_{3}$ (not shown) using the schematic in Figure 13 (b). Through the calculation in the right part of Figure 14, it can be shown that the circuit is a low-pass filter. The corner frequency is proportional to $f_{\text {clk }}$, which is the frequency of the clock signal applied to the switched capacitors $\mathrm{C}_{2}$ and $\mathrm{C}_{3}$. Thus a programmable frequency divider with a wide division ratio range is very useful for a switched capacitor filter. If
the input frequency of the divider is a fixed value, the output frequency can be changed widely. Using the programmable divider to drive the switched capacitors in Figure 14, the corner frequency of the low-pass filter can be changed widely, such as MHz down to kHz . The following relationship should exist,

$$
\begin{equation*}
f_{\text {corner }} \propto f_{\text {clk }} \propto \frac{1}{\text { division ratio }} \tag{19}
\end{equation*}
$$

There are other types of switched capacitor filters, such as high-pass, band-pass, $2^{\text {nd }}$ order and higher order filters. Their corner frequencies should also be able to be controlled by the clock frequency.

As mentioned before, clocked circuits prefer clock signals with $50 \%$ duty-cycle to be able to operate at higher frequencies. Since switched capacitor filters are clocked circuits, the programmable divider used for them should also have close to $50 \%$ output duty-cycle.

### 2.3.1.2 System-on-a-chip (SOC)

As stated in reference [22], "SOC needs multiple clocks and mostly with $50 \%$ duty-cycle in same chip," and "because many subsystems in SOC use both the rising and falling edges of the clock signals, we need to maintain a precise $50 \%$ duty-cycle to achieve the best performance for the systems. Also, use of a PLL with arbitrary frequency division $(\div \mathrm{N})$ is a well known method for synthesizing desired frequency." Using a PLL followed by several programmable frequency-dividers with different division ratios can generate clock signals with different frequencies on the same chip, as shown in Figure 15.


Figure 15: The block diagram showing the development of multi-frequency clock signals for SOCs, which needs multiple clocks and mostly with $50 \%$ duty-cycle on the same chip.

The proposed programmable frequency-divider has division ratios in a wide range and close-to-50\% output duty-cycle. Thus it could be used to generate multiple clock signals for a SOC.

### 2.3.1.3 Variable Clock Signals for Different Power States of Digital Systems

Many digital systems have different operating states, such as normal state, snoop state, and sleeping state. The systems enter low power states to reduce power when it is possible. For example, Figure 16 shows the block diagram of the Clock Control and Low Power States for the Intel ${ }^{\circledR}$ Pentium ${ }^{\circledR}$ M Processor with 2-MB L2 Cache and $533-\mathrm{MHz}$ Front Side Bus [23]. This processor has different supply-voltages and clock-frequency options for different states. Page 14 of the datasheet of this Processor [23] explains that "Multiple voltage/frequency operating points provide optimal performance at the lowest power" is a key feature of enhanced Intel speed step technology. Thus a PLL followed by the proposed programmable frequency-divider is a good option to generate different frequencies for different operating states. Since the output duty-cycle of the proposed


Figure 16: Block diagram of clock control and low power states for Intel® Pentium ${ }^{\circledR}$ M Processor with 2-MB L2 cache and 533-MHz front side bus [23] for wireless laptop computer.
divider is very close to $50 \%$, the performance of the digital systems will be optimized [24] - [26].

There are other published literatures that state $50 \%$ duty-cycle is important for double data rate (DDR) circuits. In the abstract of the paper [27], there is the following statement "For those adopting double data rate (DDR) technology systems, the precise system timing plays a crucial role since both rising and falling edges of the system clock signal are used to sample the input data. Due to this requirement, it is necessary to accurately maintain the duty-cycle of the clock signal at $50 \%$." The paper [28] states, "A duty cycle corrector (DCC) is a very important circuit for dual edge triggering systems". The
proposed design is also useful to generate clock signals with close to $50 \%$ duty-cycle for DDR circuits.

As explained in all of the above references, $50 \%$ duty-cycle of a clock signal is important for various implementations. It is easy to make the output duty-cycle of the programmable frequency-divider to be exactly $50 \%$, by adding a divide-by-2 divider at the output stage. As stated in [29], the division ratio step will be 2 by using this method. This will degrade the output-frequency resolution, since the output-frequency resolution is the smallest variation of the output frequency. While the proposed design can make the output duty-cycle very close to $50 \%$, and maintain the division ratio step to be 1 .

### 2.3.2 Smaller Layout Area

The " $2 / 3$ cell" is the basic component of the programmable frequency divider [2] as shown in Figure 7. The schematic of the " $2 / 3$ cell" is shown in Figure 17 (a). It includes three "AND-latch" gates and one "D-latch". "AND-latch" is a source coupled logic (SCL) implementation of an AND gate combined with a latch function. The circuit in Figure 17 (b) shows the previous "AND-latch" design. The circuit in Figure 17 (c) shows
 to the end " $2 / 3$ cell" stages. Figure 17 (e) shows the proposed "D-latch" circuit used in each " $2 / 3$ cell".

The passive resistor loads in the previous "AND-latch" gate in Figure 17 (b) consume much area. In "TABLE I" of [2], for the " $2 / 3$ cell" operated at 16 MHz , the load


Figure 17: Comparison of the previous design [2] and the proposed design: schematics of: (a) a " $2 / 3$ cell", (b) previous "AND-latch", (c) proposed "AND-latch" for the first " $2 / 3$ cell" stage, (d) proposed "AND-latch" for the 2 nd - the end " $2 / 3$ cell" stages, and (e) proposed D-latch in the " $2 / 3$ cell".
resistance should be $300 \mathrm{k} \Omega$. In a known $0.18-\mu \mathrm{m}$ process, the highest sheet resistance is $1006.9 \mathrm{ohm} /$ square using poly resistor. Thus $300 \mathrm{k} \Omega$ occupies about 300 unit squares. If 1 $\mu$ m-wide poly is used, $3 \times 2 \times 300=1800 \mu \mathrm{~m}^{2}$ is needed for each " $2 / 3$ cell", since each "AND-latch" gate needs 2 resistances and each " $2 / 3$ cell" contains 3 "AND- latch" gates. There are multiple " $2 / 3$ cell" in the entire divider. The proposed "AND-latch" gate as shown in Figure 17 (c) and (d) removed the passive resistors. In this way, the proposed design can significantly reduce the layout area.

## Chapter 3

## Design of the Proposed Programmable Divider

### 3.1 Design of the "2/3 Cell" Circuit

The " $2 / 3$ cell" is a divider with division ratio of 2 or 3 . Through derivations, the division ratio of the " $2 / 3$ cell" is determined by the following equation.

$$
\begin{align*}
& \text { If } \bmod _{\text {in }}=0, \bmod _{\text {out }}=0 \& f_{o}=\frac{f_{\text {in }}}{2}  \tag{20}\\
& \text { If } \bmod _{\text {in }}=1,\left\{\begin{array}{l}
p=1 \Rightarrow \bmod _{\text {out }}=f_{o}=\frac{f_{\text {in }}}{3} \\
p=0 \Rightarrow \bmod _{\text {out }}=f_{o}=\frac{f_{\text {in }}}{2}
\end{array}\right\} \Rightarrow \bmod _{\text {out }}=f_{o}=\frac{f_{\text {in }}}{2+p} \tag{21}
\end{align*}
$$

As shown in Figure 17 (a), the " $2 / 3$ cell" includes three "AND-latch" gates and one "Dlatch". Figure 17 (e) shows the proposed "D-latch" circuit used in each " $2 / 3$ cell". When "ck" is high, if " $D$ " is high and " $D b$ " is low, " $\mathrm{Q}_{\mathrm{b}}$ " should be low and " Q " should be high. The "positive feedback" is used to hold the output levels at " Q " and " $\mathrm{Q}_{\mathrm{b}}$ " when "ck" is low.

The proposed "AND-latch" designs are shown in Figure 17 (c) and (d). The circuit in Figure 17 (c) is used in the first " $2 / 3$ cell", whereas the circuit in Figure 17 (d) is used for the rest stages. In both Figure 17 (c) and (d), the "D-latch" part is used to allow the outputs to change when the clock signal "ck" is high. Transistors $\mathrm{M}_{7}$ and $\mathrm{M}_{8}$ in both circuits are used as positive feedback to hold the outputs "Q" and " $\mathrm{Q}_{\mathrm{b}}$ ". The difference between Figure 17 (c) and (d) is stated as follows. The gates of $\mathrm{M}_{5}$ and $\mathrm{M}_{6}$ in Figure 17
(d) are connected to the clock signal "ck". While in Figure 17 (c), $\mathrm{M}_{5}$ and $\mathrm{M}_{6}$ are removed, enabling the circuit to yield faster operation.

There are some concerns about the circuits in Figure 17 (c) and (d). The circuit in Figure 17 (c) is combined from the D-latch designs in the references [32]-[34] and an "AND" gate. It can achieve faster operation than the circuit in Figure 17 (d). However at low frequencies, the outputs of the circuit in Figure 17 (c) do not follow the "ck" signal well (shown in Figure 7 of [32], the duty-cycle of the output is not $50 \%$ ). The reason is that without $M_{5}$ and $M_{6}$, even when "ck" is low, voltage at $Q$ or $Q b$ can still change. They should change only when "ck" is high. The output signal " $\bmod _{\text {out }}$ " of the first stage need not drive a previous stage, since there is no previous stage. Thus it is appropriate to use the circuit in Figure 17 (c) in the first stage. Simulation and test results also show that using the circuit in Figure 17 (c) in the first stage does not violate the correct operation of the entire divider. On the other hand, since the output signals " $\bmod _{\text {out }}$ " of the 2 nd - the end stages need to drive the input signal " $\bmod _{\mathrm{in}}$ " of previous stages, their duty-cycle should be $50 \%$ for correct operation. Thus the circuit in Figure 17 (d) is used in " $2 / 3$ cell" of the $2^{\text {nd }}$ - the end stages, since its output signals follow the "ck" correctly at lower frequencies. Its output signals can only change when "ck" is high due to the existence of $\mathrm{M}_{5}, \mathrm{M}_{6}$ and $\mathrm{M}_{9}, \mathrm{M}_{10}$. Therefore, using the circuit in Figure 17 (c) at the first " $2 / 3$ cell" and the circuit in Figure 17 (d) at the rest cells can achieve fast and correct operation.

### 3.2 Division Ratio Expression of Vaucher's Design [2]

### 3.2.1 Division Ratio Expression for the Basic Architechture [2]

With the time domain analysis of the " $2 / 3$ cell", it is found that the period of the output clock signal " $f_{\text {out }}$ " is equal to the period of " $\bmod _{\text {out" }}$ signal. It is also found that the time duration when the " $\bmod _{\text {out }} "=1$ is always equal to,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{\text {out }} \text { is } 1\right)=T_{\text {in }} \tag{22}
\end{equation*}
$$

where $\mathrm{T}_{\text {in }}$ is the period of the input signal " $f_{\text {in }}$ " of the " $2 / 3$ cell". Equation (22) always exists whether the division ratio control $P$, and " $\bmod _{i n}$ " of the " $2 / 3$ cell" is $\operatorname{logic} 0$ or 1 . The time duration when the " $\bmod _{\text {out }} "=0$ is equal to,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{\text {out }} \text { is } 0\right)=\left(1+P \cdot \bmod _{\text {in }}\right) \cdot T_{\text {in }} \tag{23}
\end{equation*}
$$

It is related to the logic level of the division ratio control P , and the modulus control " $\bmod _{i n} "$.

The induction method will be used to verify the division ratio (shown in equation (1)) for the basic circuit in Figure 7 (a). Equation (1) is rewritten as follows,

$$
\begin{equation*}
\text { division ratio }=P_{0} \cdot 2^{0}+P_{1} \cdot 2^{1}+P_{2} \cdot 2^{2}+\cdots+P_{n-1} \cdot 2^{n-1}+2^{n} \tag{24}
\end{equation*}
$$

The following verification includes three sections for the induction method. In the three sections, the number of the " $2 / 3$ cell" stages will be (I) 1 , (II) 2 , and (III) $n$.


Figure 18: Schematics of the basic architecture of Vaucher's programmable divider [2], with the following number of the " $2 / 3$ cell" stages: (a) 1 , (b) 2 , and (c) $n$.
(I) Figure 18 (a) shows the circuit when there is only one " $2 / 3$ cell" in the entire divider. The division ratio control P for the $1^{s t}$ " $2 / 3$ cell" is " $\mathrm{P}_{0}$ ". According to equation (21), the division ratio will be,

$$
\begin{equation*}
\text { division ratio }=2+P_{0}=2^{0} \cdot P_{0}+2^{1} \tag{25}
\end{equation*}
$$

Equation (25) is compatible with equation (24), with $\mathrm{n}=1$.
(II) Figure 18 (b) shows the circuit when there are two " $2 / 3$ cell" stages in the entire divider.
(Case 1) According to equation (22), the time duration when " $\bmod _{1}$ " is " 1 " will be,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{1} \text { is } 1\right)=T_{\text {in } 2}=T\left(f_{1}\right) \tag{26}
\end{equation*}
$$

where $T_{\text {in } 2}$ is the period of the input signal of the 2 nd " $2 / 3$ cell", which is also the period
 " $2 / 3$ cell" " $\bmod _{1}=1 "$, according to equation (21), the division ratio of the $1^{\text {st } " 2 / 3}$ cell" will be $2+P_{0}$. The division ratio control P for the $1^{\text {st } " 2 / 3 \text { cell" is " } \mathrm{P}_{0} \text { ". The period of the }}$ output signal $f_{\text {out }}$ of the $1^{\text {st } " ~} 2 / 3$ cell", $T\left(f_{1}\right)$ will be,

$$
\begin{equation*}
T\left(f_{1}\right)=\left(2+P_{0}\right) \cdot T_{\text {in }} \tag{27}
\end{equation*}
$$

where $\mathrm{T}_{\text {in }}$ is the period of the input signal of the entire divider.
By inserting equation (27) into equation (26), the following result could be obtained,

$$
\begin{equation*}
\text { time }\left(\bmod _{1} \text { is } 1\right)=\left(2+P_{0}\right) \cdot T_{\text {in }} \tag{28}
\end{equation*}
$$

(Case 2) The division ratio control $P$ for the $2{ }^{\text {nd }} " 2 / 3$ cell" is " $P_{1}$ ". According to equation (23), the time duration when $\bmod _{1}=0$ will be,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{1} \text { is } 0\right)=\left(1+P_{1} \cdot \bmod _{\text {in2 } 2}\right) \cdot T_{\text {in } 2} \tag{29}
\end{equation*}
$$

Since " $\bmod _{\text {in2 }}$ ", the " $\bmod _{\text {in }}$ " signal of the 2 nd " $2 / 3$ cell" is connected to $V_{D D}$, " $\bmod _{\text {in2 }} "=1$. Thus equation (29) can be written as,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{1} \text { is } 0\right)=\left(1+P_{1}\right) \cdot T_{\text {in } 2}=\left(1+P_{1}\right) \cdot T\left(f_{1}\right) \tag{30}
\end{equation*}
$$

Since $\bmod _{1}=0$, according to equation (20), the division ratio of the $1^{\text {st } " ~} 2 / 3$ cell" will be 2. The period of the output signal $f_{\text {out }}$ of the $1^{\text {st }}$ " $2 / 3$ cell", $T\left(f_{1}\right)$ will be,

$$
\begin{equation*}
T\left(f_{1}\right)=2 \cdot T_{i n} \tag{31}
\end{equation*}
$$

By inserting equation (31) into equation (30), the following result could be obtained.

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{1} \text { is } 0\right)=2 \cdot\left(1+P_{1}\right) \cdot T_{i n}=\left(2+2 \cdot P_{1}\right) \cdot T_{i n} \tag{32}
\end{equation*}
$$

For the 2 nd (the end) " $2 / 3$ cell", the period of the output clock signal " $f_{\text {out" }}$ is equal to the period of the " $\bmod _{1}$ " signal. The period of the " $\bmod _{1}$ " signal will be the sum of the time duration when " $\bmod _{1}$ " is 1 and the time duration when " $\bmod _{1}$ " is 0 . Thus the output period of the entire divider will be,

$$
\begin{equation*}
T_{\text {out }}=\operatorname{time}\left(\bmod _{1} \text { is } 1\right)+\operatorname{time}\left(\bmod _{1} \text { is } 0\right) \tag{33}
\end{equation*}
$$

By inserting equation (28) and (32) into equation (33), the output period can be obtained as follows.

$$
\begin{gather*}
T_{\text {out }}=\left(2+P_{0}\right) \cdot T_{\text {in }}+\left(2+2 \cdot P_{1}\right) \cdot T_{\text {in }}  \tag{34}\\
T_{\text {out }}=\left(P_{0}+2 \cdot P_{1}+4\right) \cdot T_{\text {in }}=\left(2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+2^{2}\right) \cdot T_{\text {in }} \tag{35}
\end{gather*}
$$

Thus the division ratio of the entire divider will be,

$$
\begin{equation*}
\text { division ratio }=\frac{T_{\text {out }}}{T_{\text {in }}}=2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+2^{2} \tag{36}
\end{equation*}
$$

Equation (36) is compatible with equation (24), with $n=2$.
(III) Suppose the division ratio for a divider with $n-1$ stages of the " $2 / 3$ cell" is equal to the following expression,

$$
\begin{equation*}
\text { division ratio }(n-1 \text { stages })=2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{1} \cdot P_{n-2}+2^{n-1} \tag{37}
\end{equation*}
$$

If another stage is added after the existing $\mathrm{n}-1$ stages, the new divider will have n stages.
(Case 1) According to equation (22), the time duration when " $\bmod _{n-1}$ " is 1 will be,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{n-1} \text { is } 1\right)=T_{i n, n}=T\left(f_{n-1}\right) \tag{38}
\end{equation*}
$$

where $T_{i n, n}$ is the period of the input signal of the $n^{\text {th }}$ " $2 / 3$ cell", which is also the period of the output signal $f_{\text {out }}$ of the $(\mathrm{n}-1)^{\text {th }}$ " $2 / 3$ cell", $\mathrm{T}\left(f_{\mathrm{n}-1}\right)$. According to equation (37), the period of the output signal $f_{\text {out }}$ of the $(\mathrm{n}-1)^{\text {th }}$ " $2 / 3$ cell", $\mathrm{T}\left(f_{\mathrm{n}-1}\right)$ will be,

$$
\begin{equation*}
T\left(f_{n-1}\right)=\left(2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{1} \cdot P_{n-2}+2^{n-1}\right) \cdot T_{i n} \tag{39}
\end{equation*}
$$

By inserting equation (39) into equation (38), the following result could be obtained,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{n-1} \text { is } 1\right)=\left(2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{1} \cdot P_{n-2}+2^{n-1}\right) \cdot T_{i n} \tag{40}
\end{equation*}
$$

(Case 2) According to equation (23), the time duration when $\bmod _{1}=0$ will be,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{n-1} \text { is } 0\right)=\left(1+P_{n-1}\right) \cdot T_{i n, n}=\left(1+P_{n-1}\right) \cdot T\left(f_{n-1}\right) \tag{41}
\end{equation*}
$$

According to equation (20), if " $\bmod _{\text {in }} "=0, " \bmod _{\text {out }} "=0$. Since " $\bmod _{n-1} "=0$, all of the " $\bmod _{\text {out }}$ " signals of the previous stages will be 0 . Thus,

$$
\begin{equation*}
\bmod _{n-2}, \bmod _{n-3}, \ldots, \bmod _{1}, \bmod _{0}=0 \tag{42}
\end{equation*}
$$

Thus the division ratio of the $1^{\text {st }}-$ the $(n-1)^{\text {th }}$ " $2 / 3$ cell" will all be equal to 2 . The period of the output signal $f_{\text {out }}$ of the $(\mathrm{n}-1)^{\text {th }}$ " $2 / 3$ cell", $T\left(f_{n-1}\right)$ will be,

$$
\begin{equation*}
T\left(f_{n-1}\right)=2^{n-1} \cdot T_{i n} \tag{43}
\end{equation*}
$$

By inserting equation (43) into equation (41), the following result could be obtained,

$$
\begin{equation*}
\operatorname{time}\left(\bmod _{n-1} \text { is } 0\right)=2^{n-1} \cdot\left(1+P_{n-1}\right) \cdot T_{i n}=\left(2^{n-1}+2^{n-1} \cdot P_{n-1}\right) \cdot T_{i n} \tag{44}
\end{equation*}
$$

For the $n^{\text {th }}$ (the end) " $2 / 3$ cell", the period of the output clock signal is equal to the period of the " $\bmod _{n-1}$ " signal. The period of the " $\bmod _{n-1}$ " signal will be the sum of the time duration when " $\bmod _{n-1}$ " is 1 and the time duration when " $\bmod _{n-1}$ " is 0 . Thus the output period of the entire divider will be,

$$
\begin{equation*}
T_{\text {out }}=\operatorname{time}\left(\bmod _{n-1} \text { is } 1\right)+\operatorname{time}\left(\bmod _{n-1} \text { is } 0\right) \tag{45}
\end{equation*}
$$

By inserting equation (40) and (44) into equation (45), the output period can be obtained as follows.

$$
\begin{gather*}
T_{\text {out }}=\left(2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{1} \cdot P_{n-2}+2^{n-1}\right) \cdot T_{\text {in }}+\left(2^{n-1}+2^{n-1} \cdot P_{n-1}\right) \cdot T_{\text {in }}  \tag{46}\\
T_{\text {out }}=\left(2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{1} \cdot P_{n-2}+2^{n-1} \cdot P_{n-1}+2^{n}\right) \cdot T_{\text {in }} \tag{47}
\end{gather*}
$$

Thus the division ratio of the entire n stage divider will be,

$$
\begin{equation*}
\text { division ratio }(n \text { stage })=\frac{T_{\text {out }}}{T_{\text {in }}}=2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{1} \cdot P_{n-2}+2^{n-1} \cdot P_{n-1}+2^{n} \tag{48}
\end{equation*}
$$

It is the same as equation (24). Thus the above derivations should prove the division ratio expression of the basic architecture of Vaucher's programmable divider [2].


Figure 19: Vaucher's design with extended division range ( $2^{\min } \leq \mathrm{N} \leq 2^{\max +1}-1$ ) [2].

### 3.2.2 Division Ratio Expression for Vaucher's Design with Extended Division Range [2]

Vaucher's design with extended division range $\left(2^{\min } \leq N \leq 2^{\max +1}-1\right)$ [2], or Figure 7 (b) gives designers more division ratio options and flexibilities to use the divider in different applications. Figure 7 (b) is redrawn in Figure 19. The following derivation will explain the procedure to obtain the division ratio expression for the divider shown in Figure 19.

Compared with the basic architecture as shown in Figure 18 (b), the following differences exists: (1) several "OR" and "INV" gates are added, (2) the output signal of the entire divider is changed to the " $\bmod _{\text {out }}$ " signal of the 2 nd stage " $2 / 3$ divider", instead of using
 represents inverters.

For the example shown in Figure 19, $\min =\mathrm{n}-2, \max =\mathrm{n}$. The following derivation will explain the division ratio for three cases: (I) " $\mathrm{P}_{\mathrm{n}}=1$ ", (II) " $\mathrm{P}_{\mathrm{n}} \mathrm{P}_{\mathrm{n}-1}=0$ 1" (III) " $\mathrm{P}_{\mathrm{n}} \mathrm{P}_{\mathrm{n}-1}=0$ $0 "$.
(I) " $\mathrm{P}_{\mathrm{n}} \mathrm{P}_{\mathrm{n}-1} \mathrm{P}_{\mathrm{n}-2} \ldots \mathrm{P}_{1} \mathrm{P}_{0}=1 \mathrm{xx} \ldots \mathrm{xx} "$ " $\mathrm{P}_{\mathrm{n}} "$ is equal to logic 1 , the output of " $\mathrm{INV} V_{\mathrm{n}} "$ will be 0 . Since " $\mathrm{P}_{\mathrm{n}}$ " is equal to logic 1 , the output of the " $\mathrm{OR}_{\mathrm{n}}$ " will be 1 . Thus the output of " $\mathrm{INV} V_{\mathrm{n}-1}$ " will be 0 . Since the outputs of " $\mathrm{INV}_{\mathrm{n}}$ " and " $\mathrm{INV} V_{\mathrm{n}-1}$ " are both 0 , they will not affect the outputs of " $\mathrm{OR}_{\mathrm{n}, \mathrm{b}}$ " and " $\mathrm{OR}_{\mathrm{n}-1, \mathrm{~b}}$ ". The " $\bmod _{\mathrm{in}}$ " signal of the $(\mathrm{n}-1)^{\text {th }}$ stage will be equal to the " $\bmod _{\text {out }}$ " of the $n "$ th stage. It seems like that the " $\bmod _{\text {in }}$ " signal of the $(\mathrm{n}-1)^{\text {th }}$ stage is connected to the " $\bmod _{\text {out }}$ " of the $\mathrm{n}^{\text {th }}$ stage directly. For the same reason, it should seem like that the " $\bmod _{\text {in }}$ " signal of the $(\mathrm{n}-2)^{\text {th }}$ stage is connected to the " $\bmod _{\text {out }}$ " of the $(\mathrm{n}-1)^{\text {th }}$ stage directly. The division ratio of the entire divider will be the same as the basic architecture as shown in Figure 18 (b) with $n$ " $2 / 3$ cell" stages. Thus the division ratio will be the same as shown in equation (48), which can be rewritten as follows.

$$
\begin{equation*}
\text { division ratio }\left(P_{n} \text { is } 1\right)=2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{n-2} \cdot P_{n-2}+2^{n-1} \cdot P_{n-1}+2^{n} \cdot P_{n} \tag{49}
\end{equation*}
$$

If all of " $\mathrm{P}_{\mathrm{n}-1}$ ", $\ldots$, " $\mathrm{P}_{1}$ " and " $\mathrm{P}_{0}$ " are logic 1 , the division ratio of the divider will be the maximum value, which is $2^{\mathrm{n}+1}-1$, or $2^{\max +1}-1(\max =\mathrm{n})$.
(II) " $\mathrm{P}_{\mathrm{n}} \mathrm{P}_{\mathrm{n}-1} \mathrm{P}_{\mathrm{n}-2} \ldots \mathrm{P}_{1} \mathrm{P}_{0}=01 \mathrm{x} \ldots \mathrm{x} \times$ ". " $\mathrm{P}_{\mathrm{n}}$ " is equal to logic 0 , the outputs of " $I N V_{\mathrm{n}}$ " will be 1 . The output of " $\mathrm{OR}_{\mathrm{n}, \mathrm{b}}$ " will always be 1 . Thus the " $\bmod _{\mathrm{in}}$ " signal of the $(\mathrm{n}-1)^{\text {th }}$ stage " $2 / 3$ cell" will always be 1 . Since " $\mathrm{P}_{\mathrm{n}-1}$ " is equal to logic 1 , the output of " $\mathrm{OR}_{\mathrm{n}}$ " will be 1 . The " $\bmod _{\text {in }}$ " signal of the $(\mathrm{n}-2)^{\text {th }}$ stage will be equal to the " $\bmod _{\text {out }}$ " of the $(\mathrm{n}-1)^{\text {th }}$ stage. The division ratio of the entire divider will be the same as the basic architecture as shown in Figure 18 (b) with ( $\mathrm{n}-1$ ) " $2 / 3$ cell" stages. The division ratio when " $\mathrm{P}_{\mathrm{n}} \mathrm{P}_{\mathrm{n}-1} \mathrm{P}_{\mathrm{n}-2}$ $\ldots \mathrm{P}_{1} \mathrm{P}_{0}=01 \mathrm{x} \ldots \mathrm{xx}$ " can be written as follows.

$$
\begin{equation*}
\text { division ratio }\left(" P_{n} P_{n-1} " \text { is " } 01 \text { " }\right)=2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{n-2} \cdot P_{n-2}+2^{n-1} \tag{50}
\end{equation*}
$$

Equation (50) can be rewritten as the following one.

$$
\begin{equation*}
\text { division ratio }\left(P_{n} P_{n-1} \text { is " } 01 "\right)=2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{n-2} \cdot P_{n-2}+2^{n-1} \cdot P_{n-1}+2^{n} \cdot P_{n} \tag{51}
\end{equation*}
$$

If equation (49) and equation (51) are combined, the following result could be obtained. If any of $P_{\min +1}, P_{\min +2}, \ldots, P_{\max -1}, P_{\max }=1$, or division ratio is $\geq 2^{\min +1},(\min =n-2, \max =$ n), the division ratio will be,

$$
\begin{equation*}
\text { division ratio }=2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{n-2} \cdot P_{n-2}+2^{n-1} \cdot P_{n-1}+2^{n} \cdot P_{n} \tag{52}
\end{equation*}
$$

(III) " $\mathrm{P}_{\mathrm{n}} \mathrm{P}_{\mathrm{n}-1} \mathrm{P}_{\mathrm{n}-2} \ldots \mathrm{P}_{1} \mathrm{P}_{0}=00 \times \ldots \mathrm{xx}$ ". Both " $\mathrm{P}_{\mathrm{n}}$ " and " $\mathrm{P}_{\mathrm{n}-1}$ " are equal to logic 0 , the output of " $\mathrm{OR}_{\mathrm{n}}$ " will be 0 . The outputs of " $\mathrm{INV}_{\mathrm{n}-1}$ " will be 1 . The output of " $\mathrm{OR}_{\mathrm{n}-1, \mathrm{~b}}$ " will always be 1 . Thus the " $\bmod _{\text {in }}$ " signal of the $(n-2)^{\text {th }}$ stage " $2 / 3$ cell" will always be 1 . The output of " $\mathrm{OR}_{\mathrm{n}-1}$ " is not connected to anywhere. The division ratio of the entire divider will be the same as the basic architecture as shown in Figure 18 (b) with (n-2) " $2 / 3$ cell" stages. " $\mathrm{P}_{\mathrm{n}-2}$ " has no effect in the division ratio. The corresponding division ratio could be written as follows.

If all of $P_{\min +1}, P_{\min +2}, \ldots, P_{\max -1}, P_{\max }=0$, or division ratio is $<2^{\min +1},(\min =n-2, \max =$ n), the division ratio will be,

$$
\begin{equation*}
\text { division ratio }=2^{0} \cdot P_{0}+2^{1} \cdot P_{1}+\ldots+2^{n-3} \cdot P_{n-3}+2^{n-2} \tag{53}
\end{equation*}
$$

If all of " $\mathrm{P}_{\mathrm{n}-3}$ ", $\ldots$, " $\mathrm{P}_{1}$ " and " $\mathrm{P}_{0}$ " are logic 0 , the division ratio of the divider will be the minimum value, which is $2^{\mathrm{n}-2}$, or $2^{\min }(\min =\mathrm{n}-2)$.

For other "min" and "max" values, the division ratios can be obtained in a similar way. Thus the division ratio of Vaucher's divider [2] shown in Figure 19 is obtained.
(a) If all of $P_{\min +1}, P_{\min +2}, \ldots, P_{\max -1}, P_{\max }=0$, or division ratio is $<2^{\min +1}$,

$$
\begin{align*}
\text { division ratio } & =P_{0} \cdot 2^{0}+P_{1} \cdot 2^{1}+\cdots+P_{\min -1} \cdot 2^{\min -1}+2^{\min } \\
& =\sum_{i=0}^{\min -1} P_{i} \cdot 2^{i}+2^{\min } \tag{54}
\end{align*}
$$

(b) Other wise, if any of $\mathrm{P}_{\min +1}, \mathrm{P}_{\min +2}, \ldots, \mathrm{P}_{\max -1}, \mathrm{P}_{\max }=1$, or division ratio is $\geq 2^{\min +1}$, division ratio

$$
\begin{align*}
& =P_{0} \cdot 2^{0}+P_{1} \cdot 2^{1}+\cdots+P_{\min -1} \cdot 2^{\min -1}+P_{\min } \cdot 2^{\min }+\cdots+P_{\max -1} \cdot 2^{\max -1}+P_{\max } \cdot 2^{\max }  \tag{55}\\
& =\sum_{i=0}^{\max } P_{i} \cdot 2^{i}
\end{align*}
$$

Both equation (54) and (55) are in binary format. The special case is that when the division ratio is $<2^{\min +1}$, the control signal $\mathrm{P}_{\min }$ has no effect.

When the division ratio is $<2^{\min +1}$, $\mathrm{P}_{\text {min }}$ is set to logic " 1 ", and then equation (54) can be rewritten as,

$$
\begin{equation*}
\text { division ratio }=P_{0} \cdot 2^{0}+P_{1} \cdot 2^{1}+\cdots+P_{\min -1} \cdot 2^{\min -1}+P_{\min } \cdot 2^{\min } \tag{56}
\end{equation*}
$$

Equation (56) is compatible with equation (55). Thus equation (57) alone can be used to express the division ratio for all cases, with the following condition:

When the division ratio is $<2^{\min +1}, \mathrm{P}_{\text {min }}$ is set to logic " 1 ", then,
division ratio

$$
\begin{equation*}
=P_{0} \cdot 2^{0}+P_{1} \cdot 2^{1}+\cdots+P_{\min -1} \cdot 2^{\min -1}+P_{\min } \cdot 2^{\min }+\cdots+P_{\max -1} \cdot 2^{\max -1}+P_{\max } \cdot 2^{\max } \tag{57}
\end{equation*}
$$

For the circuit shown in Figure 19, $\min =\mathrm{n}-2$, and $\max =\mathrm{n}$.
If the division ratio is $<2^{\mathrm{n}-1}, \mathrm{P}_{\mathrm{n}-2}$ is set to logic " 1 ". The division ratio for Figure 19 will be,

$$
\begin{equation*}
\text { division ratio }=P_{0}+P_{1} \cdot 2^{1}+P_{2} \cdot 2^{2}+\cdots+P_{n-1} \cdot 2^{n-1}+P_{n} \cdot 2^{n} \tag{58}
\end{equation*}
$$

Equation (54) and (55) are quite complicated. For compactness, the following calculations will use equation (58).

### 3.3 The Proposed "Solution 1" with 50\% Duty-Cycle

The output pulse width of Vaucher's divider [2] is very narrow. Thus it has poor capability to drive other circuits. The circuit shown in Figure 20 can generate output signals with very close to $50 \%$ duty-cycle, while retaining the same division ratios as $2^{\min }$ to $2^{\max +1}-1$.

In order to achieve $50 \%$ duty-cycle, a divide-by-2 divider, "Div2", is added at the output of "Div_n_vaucher" (shown in bottom-left part of Figure 19). An "AND" gate and an "n bit half adder" are also included in the feedback loop as shown in Figure 20. Figure 21 shows the schematics of a 1-bit half adder and a 1-bit full adder. The " $n$ bit half adder" includes n stages of "1-bit half adder" connected in series. The first stage is the least


Figure 20: Schematic of the proposed "Solution 1" to generate output signal with 50\% duty-cycle.


Figure 21: Schematics of: (a) a 1-bit half adder, and (b) a 1-bit full adder.
significant bit (LSB). The "B" input of each "1-bit half adder" (shown in Figure 21 (a)) should be conntected to the "Cout" of the previous stage. The "B" input of the first "1-bit half adder" is used as "Cin" of the " $n$ bit half adder" in Figure 20.

In Figure 20 , the original output signal is " $f_{\text {out_origin }}$ " (top-middle part), whose duty cycle is far-off $50 \%$. The duty cycle of the proposed output, " $f_{\text {out }}$ " (top-right part), is very close to $50 \%$. This is because " $f_{\text {out }}$ " is the output of "Div2", and the period of " $f_{\text {out_origin" }}$ changes very little. $\mathrm{S}_{0}, \mathrm{~S}_{1}, \ldots, \mathrm{~S}_{\mathrm{n}}$ are the division ratio controls of the proposed divider. " $\mathrm{S}_{0}$ " is the LSB (Least Significant Bit). " $f_{\text {out }}$ " and " $\mathrm{S}_{0}$ " are the inputs of the "AND" gate.The output of the "AND" gate is fed to the $\mathrm{C}_{\mathrm{in}}$ input of the " n bit half-adder". The outputs of the adder are used as the division ratio controls for "Div_n_vaucher".

The binary combination of $\left(\mathrm{S}_{1}, \mathrm{~S}_{2}, \ldots, \mathrm{~S}_{\mathrm{n}}\right)$ is represented as " $m$ ", thus,

$$
\begin{equation*}
m=S_{1}+S_{2} \cdot 2^{1}+S_{3} \cdot 2^{2}+\cdots+S_{n-1} \cdot 2^{n-2}+S_{n} \cdot 2^{n-1} \tag{59}
\end{equation*}
$$

For the "Div_n_vaucher" in Figure 19, $\mathrm{P}_{\min }=\mathrm{P}_{\mathrm{n}-2}$, and $\mathrm{P}_{\max }=\mathrm{P}_{\mathrm{n}}$ as stated before. $\underline{\mathrm{P}}_{\mathrm{n}-2}$ or $\mathrm{S}_{\mathrm{n}-1}$ is set to logic " 1 " when the division ratio of "Div n vaucher" is $<2^{\mathrm{n}-1}$ (or the proposed division ratio is $<2^{\mathrm{n}}$ ). Thus equation (58) can be used to represent the division ratio of "Div_n_vaucher".

If " $\mathrm{S}_{0}$ " is 0 , the binary combination of the adder outputs will be equal to " $m$ ". The ratio of " $f_{\text {in }} / f_{\text {out_origin }}$ " will also be equal to "m". After "Div2", the ratio of " $f_{\text {in }} / f_{\text {out }}$ will be equal to,

$$
\begin{equation*}
2 \times m=0+S_{1} \cdot 2^{1}+S_{2} \cdot 2^{2}+S_{3} \cdot 2^{3}+\cdots+S_{n-1} \cdot 2^{n-1}+S_{n} \cdot 2^{n} \tag{60}
\end{equation*}
$$

If " $\mathrm{S}_{0}$ " is " 1 ", the signal at input " $\mathrm{C}_{\text {in }}$ " of the adder will oscillate between " 0 " and " 1 ", with a close to $50 \%$ duty-cycle. The binary outputs of the adder (or the division ratio of "Div_n_vaucher") will have an average value of $0.5+m$. Thus the average ratio of " $f_{\text {in }} /$ $f_{\text {out }}$ will be equal to,

$$
\begin{equation*}
2 \times(0.5+m)=1+S_{1} \cdot 2^{1}+S_{2} \cdot 2^{2}+S_{3} \cdot 2^{3}+\cdots+S_{n-1} \cdot 2^{n-1}+S_{n} \cdot 2^{n} \tag{61}
\end{equation*}
$$

If equations (60) and (61) are combined, the division ratio can be written as follows,

$$
\begin{equation*}
\text { proposed division ratio }=S_{0}+S_{1} \cdot 2^{1}+S_{2} \cdot 2^{2}+S_{3} \cdot 2^{3}+\cdots+S_{n-1} \cdot 2^{n-1}+S_{n} \cdot 2^{n} \tag{62}
\end{equation*}
$$

The proposed division ratio expressed in equation (62) is the same as the original one in equation (58) (except for that " P " is changed to " S ").

The output duty-cycle of the proposed design can be calculated as follows. When " $\mathrm{S}_{0}$ " is 0 , the division ratio is an even number as shown in equation (60). Since the adder outputs or the division ratio of "Div_n_vaucher" do not change, neither $f_{\text {out_origin }}$ nor the period $\mathrm{T}_{\text {out_origin }}$ changes. After "Dvi2", the duty-cycle of $f_{\text {out }}$ will be exactly $50 \%$. When " $\mathrm{S}_{0}$ " is 1 , the division ratio is an odd number as shown in equation (61). Since the adder outputs or the division ratio of "Div_n_vaucher" changes between $m$ and $m+1, T_{\text {out_origin }}$ changes between $m \times \mathrm{T}_{\text {in }}$ and $(m+1) \times \mathrm{T}_{\text {in }}$, where $\mathrm{T}_{\text {in }}$ is the period of the input signal. The "on" and "off" time of the proposed output signal $f_{\text {out }}$ will be $m \times \mathrm{T}_{\text {in }}$ and $(m+1) \times \mathrm{T}_{\text {in }}$. Thus when the division ratio is an odd number, the duty-cycle of the proposed output is $m /(2 m+1)$, where $2 m+1$ is the division ratio. These results are compatible with equation (16).

According to the above analysis, the proposed circuit in Figure 20 generates an output signal with close to $50 \%$ duty-cycle, also keeps the step size of the division ratio to be 1 (by changing the LSB control bit " $\mathrm{S}_{0}$ ").

### 3.4 Proposed "Solution 2" with 50\% Duty-Cycle

The above scheme, "Solution 1", does not work for the isolated division ratios of $2^{\mathrm{r}}-1$ (such as $15,31,63,127$ ), where " r " is a natural number. The proposed "Solution 2" scheme shown in Figure 22 solved this problem. Figure 22 (a) shows the top level circuit of Solution 2. Figure 22 (b) shows the revised " $2 / 3$ cell" for "Solution 2". Figure 22 (c) shows the circuit to judge the " $0 / 1$ " edge of the control digits.

It is also important to keep the uniformity of the division ratio expression as shown in equation (57). The same method could be used as in the proposed "Solution 1". It is also the requirement stated just above equation (57). When the division ratio is $<2^{\min +1}$, " $\mathrm{P}_{\min }$ " should be set to logic " 1 ".

As shown in Figure 22 (a), if a " $2 / 3$ cell" is connected to the first nonzero control-digit in the MSB (most significant bit) part, this " $2 / 3$ cell" is "on edge". For the particular example shown at the bottom of Figure 22 (a), $\mathrm{P}_{\mathrm{n}-2}$ is the first nonzero control-digit counting down from the MSB part. Thus the $(\mathrm{n}-1)^{\text {th }}$ " $2 / 3$ cell" stage, which is connected


Figure 22: Schematics of the proposed "Solution 2" for the division ratios of " 2 " -1 " with $50 \%$ output duty-cycle: (a) top level scheme, (b) circuit to generate "pulse out" in each " $2 / 3$ cell", and (c) the "on edge" judgment circuit.
with $\mathrm{P}_{\mathrm{n}-2}$ signal, is "on edge". The "pulse ${ }_{\text {out" }}$ signals from the on-edge " $2 / 3$ cell" and the previous cells have the desired output frequency, which is " $f_{\text {in }} /$ (the expected division ratio)". The "pulse ${ }_{\text {out" }}$ signals from the latter " $2 / 3$ cell" have unwanted frequencies, which are different from " $f_{\text {in }} /$ (the expected division ratio)". Among the "pulse ${ }_{\text {out }}$ " signals from the on-edge " $2 / 3$ cell" and the previous cells, the signal from the on-edge cell has a dutycycle closest to $50 \%$. Thus the "pulse ${ }_{\text {out" }}$ signal from this on-edge cell will be used as the output for the entire divider.

Figure 22 (b) shows the revised " $2 / 3$ cell". It is drawn in a differential mode, for example both "D" and "Db" are drawn in the "D-latch". Actually, the only difference between the revised " $2 / 3$ cell" and the one shown in Figure 17 (a) is that an "OR" gate is added in the revised one to generate the "pulse ${ }_{\text {out" }}$ signal. The signals " $\mathrm{Q}_{1}$ " and " $\bmod _{\text {out" }}$ are the inputs of the "OR" gate. When the division ratio is a " 2 r -1 " number, the "pulse ${ }_{\text {out }}$ " signal of the "on-edge" " $2 / 3$ cell" has a duty-cycle of $\frac{k}{2 k+1}$, where $2 k+1=2^{r}-1$ or the division ratio. Since the division ratio " 2 r -1 " is an odd number, this duty-cycle is compatible with the expression shown in equation (16).

Figure 22 (c) shows the circuit to judge the " $0 / 1$ " edge of the control digits, or the first nonzero control-digit in the MSB part. In the figure, the expressions have the following meaning,

$$
\begin{equation*}
\sum_{j=i+1}^{n} P(j)=\left(P_{j+1}\right) O R\left(P_{j+2}\right) O R \ldots O R\left(P_{n-1}\right) O R\left(P_{n}\right) \tag{63}
\end{equation*}
$$

$$
\begin{equation*}
\overline{\sum_{j=i+1}^{n} P(j)}=\operatorname{NOT}\left(\sum_{j=i+1}^{n} P(j)\right) \tag{64}
\end{equation*}
$$

As the example shown in Figure 22 (c), if " $\mathrm{P}_{\mathrm{n}} \mathrm{P}_{\mathrm{n}-1} \mathrm{P}_{\mathrm{n}-2}=001$ ", $\mathrm{P}_{\mathrm{n}-2}$ will be the first nonzero control-digit counting down from the MSB part. If "OR" operations are applied to all the MSB digits before $\mathrm{P}_{\mathrm{n}-2}$, the result will be 0 . The inversion of this result 0 is 1 . If "AND" operation is applied to the inversion signal " 1 " and $\mathrm{P}_{\mathrm{n}-2}$, the result will be 1 . Only when $P_{n-2}$ is "on-edge", the result will be 1 . The results for other control digits will all be 0 . By implementing the combination of "OR", "AND" and "inverter" logic gates, the " $\mathrm{P}_{\mathrm{n}-2}$ is on edge?" signal will be high. Thus the circuit shown in Figure 22 (c) can judge the on-edge cell automatically.

The proposed "Solution 2" shown in Figure 22 can solve the problem of the proposed "Solution 1". When the division ratio is " 2 " -1 " number, the output duty-cycle of "Solution 2 " is $\frac{k}{2 k+1}$, where $2 k+1$ is the division ratio.

### 3.5 Combination of the Proposed Solution 1 and 2 with 50\% DutyCycle

To obtain close-to-50\% output duty-cycle for each division ratio, the proposed "Solution 1" and "Solution 2" are combined together, as shown in Figure 23. With the circuit shown in Figure 24, the proposed divider will automatically judge if the division ratio has


Figure 23: Combination of "Solution 1" and "Solution 2" in the proposed design.


Figure 24: Division ratio judgment circuit.
the " $2^{r}-1$ " format. If the division ratio is not a " $2^{r}-1$ " number, the control digits " $\mathrm{S}_{0} \mathrm{~S}_{1} \ldots \mathrm{~S}_{\mathrm{n}}$ " will be assigned to the adder inputs and the AND gate input as shown in Figure 20. Thus the adder outputs will be used to control the division ratio of "Div_n_vaucher". "Div2" output shown in Figure 20 is used as the final output. Otherwise, if the division ratio is a " $2^{\mathrm{r}}-1$ " number, the control digits " $\mathrm{S}_{0} \mathrm{~S}_{1} \ldots \mathrm{~S}_{\mathrm{n}}$ " are assigned directly to the controls " $\mathrm{P}_{0} \mathrm{P}_{1} \ldots \mathrm{P}_{\mathrm{n}}$ " of "Div_n_Vaucher"(the circuit shown in Figure 22 (a)). The output shown in Figure 22 (a) is used as the final output. In order to keep the uniformity of the division ratio expression, when the division ratio is $<2^{\min +1}$, $\mathrm{S}_{\text {min }}$ should be set to logic " 1 " similarly to equation (57). Here " $\mathrm{S}_{0} \mathrm{~S}_{1} \ldots \mathrm{~S}_{\mathrm{n}}$ " are the division ratio controls of the top level design.

Figure 24 shows the circuit to judge if the division ratio is a " $2^{r}-1$ " number. Some expressions at the bottom of the Figure 24 have the following meaning,

$$
\begin{align*}
& \sum_{j=i+1}^{n} S(j)=\left(S_{j+1}\right) O R\left(S_{j+2}\right) O R \ldots O R\left(S_{n-1}\right) O R\left(S_{n}\right)  \tag{65}\\
& \prod_{j=0}^{i} S(j)=\left(S_{0}\right) A N D\left(S_{1}\right) A N D \ldots A N D\left(S_{i-1}\right) \operatorname{AND}\left(S_{i}\right) \tag{66}
\end{align*}
$$

If a number has the " $2^{r}-1$ " format, it should be able to be expressed in binary format as " $0 \ldots 01 \ldots 111$ ". Number $i_{\text {edge }}$ is used to represent the index of the first nonzero digit counting down from the MSB (left) part. For the example shown in Figure 24, if $\mathrm{S}_{\mathrm{n}} \mathrm{S}_{\mathrm{n}}$. ${ }_{1} \mathrm{~S}_{\mathrm{n}-2} \ldots \mathrm{~S}_{2} \mathrm{~S}_{1} \mathrm{~S}_{0}=001 \ldots 111$, the division ratio is a " $2 \mathrm{r}-1$ " number, and $\mathrm{r}=\mathrm{n}-1$. The first nonzero MSB control digit is $\mathrm{S}_{\mathrm{n}-2}$, so $i_{\text {edge }}=\mathrm{n}-2$. The MSB digits " $\mathrm{S}_{\mathrm{n}}$ " and " $\mathrm{S}_{\mathrm{n}-1}$ ", the
digits left to $\mathrm{S}_{\mathrm{n}-2}$, are all 0 . If the logic "OR" operations are applied to all of the MSB digits " $\mathrm{S}_{\mathrm{n}}$ " and " $\mathrm{S}_{\mathrm{n}-1}$ ",

$$
\begin{equation*}
A=\sum_{j=i+1}^{n} S(j)=0 \Rightarrow \bar{A}=1, \text { here } i=\mathrm{n}-2 . \tag{67}
\end{equation*}
$$

If the logic "AND" operations are applied to all of the LSB digits (including digit $\mathrm{S}_{n-2}$ ), " $\mathrm{S}_{\mathrm{n}-2} ", \ldots$, " $\mathrm{S}_{2}$ ", " $\mathrm{S}_{1}$ ", " $\mathrm{S}_{0}$ ", the following result will be obtained.

$$
\begin{gather*}
B=\prod_{j=0}^{i} S(j)=1, \text { where } i=\mathrm{n}-2 .  \tag{68}\\
\text { Thus } \overline{\sum_{j=i+1}^{n} S(j)} \bullet \prod_{j=0}^{i} S(j)=\bar{A} \bullet B=1, \text { where } i=\mathrm{n}-2 . \tag{69}
\end{gather*}
$$

In the middle part of Figure 24, the gates "AND ${ }_{1} ",{ }^{\prime} A N D_{2} ", \ldots$, "AND ${ }_{n-1}$ " are used to realize the logic "AND" operations $B=\prod_{j=0}^{i} S(j)$ in the circuit. The gates " $\mathrm{OR}_{1} "$, " $\mathrm{OR}_{2} ", \ldots$, "OR ${ }_{\mathrm{n}-1}$ " are used to realize the logic "OR" operations $A=\sum_{j=i+1}^{n} S(j)$. At the upper part of Figure 24 , the small circles " 0 " at the inputs of " $A N D_{1, b}$ ", $\ldots$, " $\mathrm{AND}_{\mathrm{n}-2, \mathrm{~b}}$ ", " $\mathrm{AND}_{\mathrm{n}-1, \mathrm{~b}}$ " are inverters. They are applied to $A$ to realize the logic "NOT" operation to obtain $\bar{A}$. An "AND" gate is used to apply the logic "AND" operation to $\bar{A}$ and $B$, to obtain $\bar{A} \cdot B$. Thus each signal "Div $2^{\mathrm{r}}-1$ ?" represents the result of $\bar{A} \cdot B=\overline{\sum_{j=i+1}^{n} S(j)} \cdot \prod_{j=0}^{i} S(j)$ for the corresponding $i$. For the above example, since $S_{n} S_{n-1} S_{n-2} \ldots S_{2} S_{1} S_{0}=001 \ldots 111$,

$$
\begin{equation*}
\overline{\sum_{j=i+1}^{n} S(j)} \cdot \prod_{j=0}^{i} S(j)=1 \text { for } i=\mathrm{n}-2 \tag{70}
\end{equation*}
$$

Thus the signal "Div $2^{\mathrm{r}}-1$ ?" above " $\mathrm{AND}_{\mathrm{n}-2, \mathrm{~b}}$ " is " 1 ", where $\mathrm{n}-2$ is $i_{\text {edge }}$. If $\overline{\sum_{j=i+1}^{n} S(j)} \bullet \prod_{j=0}^{i} S(j)=1$ for any particular index $i \in[1, n-1]$, the division ratio " $\mathrm{S}_{\mathrm{n}} \mathrm{S}_{\mathrm{n}-1} \mathrm{~S}_{\mathrm{n}-2} \ldots$ $\mathrm{S}_{2} \mathrm{~S}_{1} \mathrm{~S}_{0}$ " should be a " $2^{\mathrm{r}}-1$ " number. This particular index $i$ will be $i_{\text {edge }}$, the index of the first nonzero control digit counting down from the MSB part. At the top part of Figure 24, gates " $\mathrm{OR}_{1, \mathrm{~b}}$ ", $\ldots$, " $\mathrm{OR}_{\mathrm{n}-2, \mathrm{~b}}$ ", " $\mathrm{OR}_{\mathrm{n}-1, \mathrm{~b}}$ " are above the "Div $2^{\mathrm{r}}-1$ ?" signals. If any "Div $2^{\mathrm{r}}-1$ ?" signal is " 1 ", with the logic "OR" operations, the output signal "Select solution 2?" will be " 1 ". Thus if the division ratio " $\mathrm{S}_{\mathrm{n}} \mathrm{S}_{\mathrm{n}-1} \mathrm{~S}_{\mathrm{n}-2} \ldots \mathrm{~S}_{2} \mathrm{~S}_{1} \mathrm{~S}_{0}$ " is a " $2^{\mathrm{r}}-1$ " number, for any natural number " $\mathrm{r} \in[1, n-1]$ ", the circuit will select Solution 2.

Figure 25 shows a more detailed top-level schematic of the proposed design. The "division ratio judgment circuit" used in Figure 25 at the left-bottom corner has been shown in Figure 24. If the division ratio is a " $2^{\mathrm{r}}-1$ " number, the "division ratio judgment circuit" in Figure 25 will give an output "1". In this case, "Solution 2" will be used. The " $\mathrm{n}+1$ bit MUX" circuit in the middle of Figure 25 will be used to select signals to assign the " $\mathrm{P}_{0} \mathrm{P}_{1} \ldots \mathrm{P}_{\mathrm{n}}$ " controls of "Div_n_vaucher". If "Solution 2 " is used, " $\mathrm{S}_{0} \mathrm{~S}_{1} \ldots \mathrm{~S}_{\mathrm{n}}$ " will be selected and assigned to " $\mathrm{P}_{0} \mathrm{P}_{1} \ldots \mathrm{P}_{\mathrm{n}}$ " of "Div_n_vaucher". If the division ratio is not a " 2 r -1 " number, "Solution 1" will be used. The division ratio control digits " $\mathrm{S}_{0} \mathrm{~S}_{1} \ldots \mathrm{~S}_{\mathrm{n}}$ " will be assigned to the inputs of the adder and the "AND" gate. The " $n+1$ bit MUX" circuit will select adder outputs and assign them to the " $\mathrm{P}_{0} \mathrm{P}_{1} \ldots \mathrm{P}_{\mathrm{n}}$ " controls of "Div_n_vaucher". The "Div_n_vaucher" for the combined proposed divider is the entire circuit of "Solution 2" as shown in Figure 22 (a). The "MUX" circuit at the top of Figure 25 gives the final output by selecting "Solution 1 output" or "Solution 2 output".


Figure 25: A more detailed schematic of the top-level proposed design.

Since all the additional circuits in the proposed design (for duty-cycle correction) operate at relatively low frequencies, they only adds less than $10 \%$ power consumption penalty to the original divider.

### 3.6 Simulations of the Proposed Divider

Simulations were performed for the proposed-design. They verify that the proposed programmable divider realized the division ratios shown in equation (62) and has the output duty-cycle very close to $50 \%$ as shown in equation (16). Table 2 shows the prelayout simulation results for the comparison of Process-Voltage-Temperature (PVT) performance of the proposed design. When the temperature is lower or $\mathrm{V}_{\mathrm{DD}}$ is higher, or with a faster process corner, the maximum operating-frequency is higher. For each division ratio, the output duty-cycle of the proposed design remains constant with various PVT, with various input frequencies, and with different chips.

### 3.7 Phase Noise Analysis of the Proposed Divider

A few references [35]-[36] state the noise analysis of frequency dividers. References [35] carried out the noise analysis for dividers using CMOS transistors, which is similar to the proposed divider.

Accorder to [35], for a synchronized frequency divider, the output phase noise is the accumulation of the phase noise in each " $2 / 3$ cell" stage. In each " $2 / 3$ cell" stage, the

Table 2: Performance of the proposed divider for various process-voltage-temperature
(a) The maximum operating-frequency vs. $\mathrm{V}_{\mathrm{DD}}$ and Temperature, process $=\mathrm{tt}$

|  | $\mathrm{V}_{\mathrm{DD}}=1.6 \mathrm{~V}$ | $\mathrm{~V}_{\mathrm{DD}}=1.8 \mathrm{~V}$ | $\mathrm{~V}_{\mathrm{DD}}=2 \mathrm{~V}$ |
| :---: | :---: | :---: | :---: |
| Temp $=-40^{\circ} \mathrm{C}$ | 5.8 GHz | 6.7 GHz | 7.5 GHz |
| Temp $=0^{\circ} \mathrm{C}$ | 5.3 GHz | 6.1 GHz | 6.8 GHz |
| Temp $=27^{\circ} \mathrm{C}$ | 5.1 GHz | 5.8 GHz | 6.4 GHz |
| Temp $=50^{\circ} \mathrm{C}$ | 4.9 GHz | 5.5 GHz | 6.2 GHz |
| Temp $=85^{\circ} \mathrm{C}$ | 4.6 GHz | 5.2 GHz | 5.8 GHz |
|  |  |  |  |

(b) The maximum operating-frequency vs. process corner $(0.18-\mu \mathrm{m}) \mathrm{V}_{\mathrm{DD}}=1.8 \mathrm{~V}$,

$$
\text { temperature }=27^{\circ} \mathrm{C}
$$

| Process | $f_{\text {in }}$ |
| :---: | :---: |
| $\mathbf{f f}$ | 7.4 GHz |
| $\mathbf{t t}$ | 5.8 GHz |
| $\mathbf{s s}$ | 4.6 GHz |

phase noise is caused by both the thermal noise and flicker noise caused by certain transistors.

The entire thermal noise can be written as the following equation, as shown in equation (10) of [35],

$$
\begin{equation*}
L_{w}=8 \pi^{2} \cdot\left(1+\frac{\gamma}{\alpha}+\frac{\gamma_{T} g_{m T} R_{L}}{2 \alpha_{T}}\right) \cdot \frac{k T C_{L}}{I_{B}{ }^{2}} \cdot f_{\text {out }} \tag{71}
\end{equation*}
$$

where $\gamma \cong 1$, and $\alpha \cong 0.6$ for the input differential pair. $\gamma_{T} \cong 2 / 3$, and $\alpha_{T} \cong 1$ for the longchannel MOS transistor to generate the tail current. $\mathrm{g}_{\mathrm{mT}}$ is the transistor transconductance, which generates the tail current. $\mathrm{R}_{\mathrm{L}}$ is the equivalent resistance of the PMOS transistors. The PMOS transistors will operate in linear region, when their gates are connected to $\mathrm{V}_{\mathrm{SS}}$, and their drain voltages are at $\mathrm{V}_{\mathrm{DD}} / 2 . \mathrm{R}_{\mathrm{L}}$ can be expressed as the following equation [37], when a PMOS transistor is operating in the linear region,

$$
\begin{equation*}
R_{L}=\frac{1}{\mu_{p} C_{o x} \frac{W}{L}\left(V_{S G}-\left|V_{t h p}\right|\right)} \tag{72}
\end{equation*}
$$

$k$ is the Boltzmann constant, which is $1.38 \times 10^{-23} \mathrm{~J} / \mathrm{K} . \mathrm{T}$ is the absolute temperature. $\mathrm{C}_{\mathrm{L}}$ is the load capacitor for each " $2 / 3$ cell" stage. $I_{B}$ is the current flowing in each transistor is the input differential pair, when $V_{\text {out }}=\overline{V_{\text {out }}} . f_{\text {out }}$ is the output frequency of the " $2 / 3$ cell" stage.

The flicker noise of the input differential NMOS pair will affect the output phase noise. The flicker noise at the offset frequency $f$ can be written as the following equation, as shown in equation (13) of [35],

$$
\begin{equation*}
L_{F}(f)=2 \pi^{2} f_{\text {out }}{ }^{2} \cdot\left(\frac{C_{L}}{I_{B}}\right)^{2} \cdot \frac{2 K_{f}}{f} \tag{73}
\end{equation*}
$$

where $f_{\text {out }}$ is the output frequency of the " $2 / 3$ cell" stage. $\mathrm{C}_{\mathrm{L}}$ is the load capacitor for each " $2 / 3$ cell" stage. $I_{B}$ is the current flowing in each transistor of the input differential pair, when $V_{\text {out }}=\overline{V_{\text {out }}} . f$ is the offset frequency, the frequency difference from $f_{\text {out }} . \mathrm{K}_{f}$ is expressed in the following equation [37],

$$
\begin{equation*}
K_{f}=\frac{K}{C_{o x} W L} \tag{74}
\end{equation*}
$$

In equation (74), K has a value about $10^{-25} \mathrm{~V}^{2} \cdot \mathrm{~F} . \mathrm{C}_{\mathrm{ox}}$ is the oxide capacitance per unit area. W and L are the width and length of the corresponding transistor.

The phase noise of each " $2 / 3$ cell" stage should be the sum of equation (71) and (73). The phase noise of the entire divider should be the sum of the phase noise of each " $2 / 3$ cell" stage and the output buffers.

Some phase noise simulations are carried out for the proposed " $2 / 3$ cell" as shown in Figure 26. Figure $26(\mathrm{a})$ is for the $1^{\text {st }}$ stage, with the simulation conditions that $f_{\text {in }}=2.4$ GHz , and division ratio $=3$. Figure $26(\mathrm{~b})$ is for the latter " $2 / 3$ cell", with $f_{\text {in }}=100 \mathrm{MHz}$, and division ratio $=3$. At 10 kHz offset from the output frequency, the phase noise of the $1^{\text {st }}$ stage " $2 / 3$ cell" is -132.563 dB . At 10 kHz offset from the output frequency, the phase noise of the slow " $2 / 3$ cell" is -126.841 dB . It can be seen that the phase noise of the slow " $2 / 3$ cell" is higher than the $1^{\text {st }}$ stage " $2 / 3$ cell".


Figure 26: Phase noise simulation of the proposed " $2 / 3$ cell": (a) $1^{\text {st }}$ stage, $f_{\text {in }}=2.4 \mathrm{GHz}$, division ratio $=3$, (b) the slow " $2 / 3$ cell", $f_{\text {in }}=100 \mathrm{MHz}$, division ratio $=3$.

### 3.8 Three Copies of the Proposed Programmable Divider

The chip includes three copies of the proposed divider to test the divider with both high and low input frequencies. The input signal $\left(f_{\text {in }}\right)$ of the first copy will be connected to a high frequency signal generator (Agilent E8257D PSG Analog Signal Generator) to test GHz range signals. The high-frequency input signals will be amplified by several buffer cells shown in Figure 27 (a). In Figure 27 (a), $\mathrm{C}_{1}$ and $\mathrm{C}_{2}$ high pass the input signals and apply the signals to the differential pair $M_{2}$ and $M_{3} . M_{6}, M_{7}$ and $M_{8}, M_{9}$ are used to generate input biasing voltage for the differential pair. The optimum biasing voltage and $\mathrm{C}_{1}, \mathrm{C}_{2}$ values are obtained through simulation to achieve the largest amplification, when several buffer cells are connected in series. The buffer cells can only amplify high frequency signals (higher than about 500 MHz ). The signal generator can only generate


Figure 27: Schematic of the high frequency buffer: (a) one differential cell, (b) several cells to convert a single-ended signal to differential output signals.
single-ended signals, but the proposed divider needs differential inputs. As shown in Figure 27 (b), several cascade buffers with one input connected to 0 V can convert the single-ended input signal to differential output signals.

The input signal $\left(f_{\text {in }}\right)$ of the second copy is coming from an on-chip ring-VCO. This input signal will also be amplified by several high-frequency buffer stages. The input signal ( $f_{\text {in }}$ ) of the third copy will be connected to a low frequency signal generator (Tektronix AFG3102 Dual Channel Arbitrary/Function Generator), which generates $50 \mathrm{MHz}-\mathrm{kHz}$ range signals. Several inverters are used to generate differential signals from the third input signals, which is a single-ended signal.

## Chapter 4

## Measurements of the Proposed Programmable Divider

### 4.1 Photographs of the Fabricated Chip and the Test Board

The chip was fabricated using a $0.18-\mu \mathrm{m}$ RF CMOS process. Figure 28 shows the photograph of the fabricated chip. The chip includes three copies of the proposed divider to test the divider with both high and low input frequencies. Each copy consumes an area of about $0.1 \mathrm{~mm}^{2}$. A RF (radio frequency) PCB (printed circuit board) is designed to test the proposed divider and a fractional PLL including the proposed divider. The PLL occupies and area of about $0.8 \mathrm{~mm}^{2}$ and it will be discussed in more details later.

Figure 29 shows the photograph of the PCB , which is a 4-layer board. Compared with a 2-layer PCB design, a 4-layer board has the following advantages. With the same total thickness of all the layers, the distance between two nearby layers will be greatly reduced. With a smaller distance between two layers, the $50 \Omega$ transmission line drawn on the board will have much smaller width. This is very helpful to layout the PCB compactly.

### 4.2 Test Results of the Proposed Divider

The proposed programmable frequency-divider is tested using an oscilloscope to check the output duty-cycle for both high frequency and low frequency input signals. Close-to$50 \%$ output signals are obtained.


Figure 28: Photograph of the proposed programmable divider after fabrication.


Figure 29: PCB test board for the proposed programmable frequency divider.

Figure 30 shows the transient test results of the proposed design with a 2.9 GHz input signal with different division ratios. A Tektronix TDS 340A digital real-time oscilloscope with 100 MHz BW is used for the measurements. The division ratios include " $2 \mathrm{r}-1$ " numbers ((a) 127 (c) 255), and other numbers ((b) 254 (d) 510). For simplicity, transient measurements with other division ratios are not shown here. Since the bandwidth of the oscilloscope is limited, it is hard to view the waveform for small division ratios. In Figure 30 it can be seen that for each division ratio, the output duty-cycle is very close to $50 \%$. Figure 31 shows the output spectra for more division ratios (a) 8 (b) 15 (c) 62 (d) 240 . An Agilent E4407B spectra analyzer is used for the spectra measurements.

Figure 32 shows the transient test results of the proposed design with a 500 MHz input signal and with different division ratios. The division ratios include " 2 r -1 " numbers ((a) 15), and other numbers ((b) 16 (c) 251 (d) 509). Figure 33 shows the transient test results of the proposed design with a 10 MHz input signal with different division ratios (a) 8 (b) 29 (c) 59 (d) 123. Figure 34 shows the transient test results of the proposed design with a 1 kHz input signal with different division ratios (a) 11 (b) 15 (c) 31 (d) 67. The output duty-cycle in each figure is close to $50 \%$ as expected. Table 3 - Table 10 shows the comparison of calculated and measured results of the proposed divider, when the input frequencies are $2.9 \mathrm{GHz}, 500 \mathrm{MHz}, 50 \mathrm{MHz}, 10 \mathrm{MHz}, 1 \mathrm{MHz}, 100 \mathrm{kHz}, 10 \mathrm{kHz}$ and 1 kHz . The comparisons are about the output frequency and the output duty-cycle. The calculation of the output duty-cycle is based on equation (16). Since the bandwidth of the oscilloscope (Tektronix TDS 340A) is limited (about 100 MHz ), when the output


Figure 30: Transient test results of the proposed design with a 2.9 GHz input signal with division ratios: (a) 127, (b) 254 , (c) 255 , and (d) 510 .

(a) Divided by 8 , calculated $\mathrm{f}_{\text {out }}=2.9 \mathrm{GHz} / 8=362.5 \mathrm{MHz}$

(c) Divided by 62, calculated $\mathrm{f}_{\text {out }}=46.77 \mathrm{MHz}$

(b) Divided by 15 , calculated $\mathrm{f}_{\text {out }}=193.33 \mathrm{MHz}$

(d) Divided by 240 , calculated $\mathrm{f}_{\text {out }}=12.083 \mathrm{MHz}$

Figure 31: Output spectra of the proposed design with a 2.9 GHz input signal with division ratios: (a) 8 , (b) 15 , (c) 62 , and (d) 240 .


Figure 32: Transient test results of the proposed design with a 500 MHz input signal with division ratios: (a) 15 , (b) 16 , (c) 251 , and (d) 509 .


Figure 33: Transient test results of the proposed design with a 10 MHz input signal with division ratios: (a) 8 , (b) 29 , (c) 59 , and (d) 123 .


Figure 34: Transient test results of the proposed design with a 1 kHz input signal with division ratios: (a) 11 , (b) 15 , (c) 31 , and (d) 67 .

Table 3: Comparison of the calculated and the measured results of the proposed divider for the input frequency of 2.9 GHz .

| Division <br> ratio | Calculated <br> $f_{\text {out }}$ <br> (MHz) | Measured <br> $f_{\text {out }}$ <br> $(\mathrm{MHz})$ | Calculated <br> output <br> duty-cycle | Measured <br> output <br> duty-cycle |
| :---: | :---: | :---: | :---: | :---: |
| 127 | 22.83 | 22.81 | $49.6 \%$ | $49.8 \%$ |
| 240 | 12.08 | 12.08 | $50.0 \%$ | $49.5 \%$ |
| 252 | 11.51 | 11.51 | $50.0 \%$ | $49.5 \%$ |
| 253 | 11.46 | 11.46 | $49.8 \%$ | $49.7 \%$ |
| 254 | 11.42 | 11.42 | $50.0 \%$ | $49.6 \%$ |
| 255 | 11.37 | 11.38 | $49.8 \%$ | $50.0 \%$ |
| 510 | 5.686 | 5.681 | $50.0 \%$ | $49.8 \%$ |

Table 4: Comparison of the calculated and the measured results of the proposed divider for the input frequency of 500 MHz .

| Division <br> ratio | Calculated <br> $f_{\text {out }}$ <br> (MHz) | Measured <br> $f_{\text {out }}$ <br> (MHz) | Calculated <br> output <br> duty-cycle | Measured <br> output <br> duty-cycle |
| :---: | :---: | :---: | :---: | :---: |
| 15 | 33.33 | 33.33 | $46.7 \%$ | $48.0 \%$ |
| 16 | 31.25 | 31.24 | $50.0 \%$ | $50.0 \%$ |
| 17 | 29.41 | 29.42 | $47.1 \%$ | $49.3 \%$ |
| 31 | 16.13 | 16.13 | $48.4 \%$ | $46.9 \%$ |
| 61 | 8.197 | 8.196 | $49.2 \%$ | $50.0 \%$ |
| 63 | 7.937 | 7.936 | $49.2 \%$ | $49.4 \%$ |
| 125 | 4 | 4 | $49.6 \%$ | $49.8 \%$ |
| 251 | 1.992 | 1.992 | $49.8 \%$ | $49.9 \%$ |
| 509 | 0.9823 | 0.9821 | $49.9 \%$ | $50.0 \%$ |
| 510 | 0.9804 | 0.9804 | $50.0 \%$ | $49.9 \%$ |

Table 5: Comparison of the calculated and the measured results of the proposed divider for the input frequency of 50 MHz .

| Division <br> ratio | Calculated <br> $f_{\text {out }}$ <br> (MHz) | Measured <br> $f_{\text {out }}$ <br> $(\mathrm{MHz})$ | Calculated <br> output <br> duty-cycle | Measured <br> output <br> duty-cycle |
| :---: | :---: | :---: | :---: | :---: |
| 8 | 6.25 | 6.251 | $50.0 \%$ | $49.9 \%$ |
| 9 | 5.556 | 5.555 | $44.4 \%$ | $44.1 \%$ |
| 11 | 4.545 | 4.544 | $45.5 \%$ | $45.3 \%$ |
| 15 | 3.333 | 3.333 | $46.7 \%$ | $46.7 \%$ |
| 31 | 1.613 | 1.613 | $48.4 \%$ | $48.3 \%$ |
| 61 | 0.8197 | 0.8197 | $49.2 \%$ | $49.2 \%$ |
| 125 | 0.4 | 0.4 | $49.6 \%$ | $49.6 \%$ |
| 127 | 0.3937 | 0.3937 | $49.6 \%$ | $49.6 \%$ |
| 251 | 0.1992 | 0.1992 | $49.8 \%$ | $49.8 \%$ |
| 255 | 0.1961 | 0.1961 | $49.8 \%$ | $49.8 \%$ |
| 509 | 0.09823 | 0.09824 | $49.9 \%$ | $49.9 \%$ |

Table 6: Comparison of the calculated and the measured results of the proposed divider for the input frequency of 10 MHz .

| Division <br> ratio | Calculated <br> $f_{\text {out }}(\mathrm{kHz})$ | Measured <br> $f_{\text {out }}(\mathrm{kHz})$ | Calculated <br> output <br> duty-cycle | Measured <br> output <br> duty-cycle |
| :---: | :---: | :---: | :---: | :---: |
| 8 | 1250 | 1250 | $50.0 \%$ | $50.0 \%$ |
| 9 | 1111.1 | 1111.1 | $44.4 \%$ | $44.4 \%$ |
| 13 | 769.2 | $769 / 2$ | $46.1 \%$ | $46.2 \%$ |
| 15 | 666.7 | 666.7 | $46.6 \%$ | $46.6 \%$ |
| 29 | 344.8 | 344.8 | $48.3 \%$ | $48.3 \%$ |
| 31 | 322.6 | 322.6 | $48.3 \%$ | $48.3 \%$ |
| 45 | 222.2 | 222.2 | $48.9 \%$ | $48.9 \%$ |
| 59 | 169.5 | 169.5 | $49.1 \%$ | $49.2 \%$ |
| 111 | 90.09 | 90.09 | $49.5 \%$ | $49.5 \%$ |
| 123 | 81.3 | 81.3 | $49.6 \%$ | $49.6 \%$ |

Table 7: Comparison of the calculated and the measured results of the proposed divider for the input frequency of 1 MHz .

| Division <br> ratio | Calculated <br> $f_{\text {out }}(\mathrm{kHz})$ | Measured <br> $f_{\text {out }}(\mathrm{kHz})$ | Calculated <br> output <br> duty-cycle | Measured <br> output <br> duty-cycle |
| :---: | :---: | :---: | :---: | :---: |
| 9 | 111.1 | 111.1 | $44.4 \%$ | $44.4 \%$ |
| 15 | 66.67 | 66.67 | $46.7 \%$ | $46.7 \%$ |
| 17 | 58.82 | 58.82 | $47.1 \%$ | $47.1 \%$ |
| 25 | 40 | 40 | $48.0 \%$ | $48.0 \%$ |
| 31 | 32.26 | 32.26 | $48.4 \%$ | $48.4 \%$ |
| 33 | 30.3 | 30.3 | $48.5 \%$ | $48.5 \%$ |
| 41 | 24.39 | 24.39 | $48.8 \%$ | $48.8 \%$ |
| 60 | 16.67 | 16.67 | $50.0 \%$ | $50.0 \%$ |
| 63 | 15.87 | 15.87 | $49.2 \%$ | $49.2 \%$ |
| 71 | 14.08 | 14.08 | $49.3 \%$ | $49.3 \%$ |

Table 8: Comparison of the calculated and the measured results of the proposed divider for the input frequency of 100 kHz .

| Division <br> ratio | Calculated <br> $f_{\text {out }}(\mathrm{kHz})$ | Measured <br> $f_{\text {out }}(\mathrm{kHz})$ | Calculated <br> output <br> duty-cycle | Measured <br> output <br> duty-cycle |
| :---: | :---: | :---: | :---: | :---: |
| 9 | 11.11 | 11.11 | $44.4 \%$ | $44.4 \%$ |
| 12 | 8.333 | 8.333 | $50.0 \%$ | $50.0 \%$ |
| 15 | 6.667 | 6.667 | $46.7 \%$ | $46.7 \%$ |
| 21 | 4.762 | 4.762 | $47.6 \%$ | $47.6 \%$ |
| 27 | 3.704 | 3.704 | $48.1 \%$ | $48.1 \%$ |
| 31 | 3.226 | 3.226 | $48.4 \%$ | $48.4 \%$ |
| 47 | 2.128 | 2.128 | $48.9 \%$ | $48.9 \%$ |
| 57 | 1.754 | 1.754 | $49.1 \%$ | $49.1 \%$ |
| 63 | 1.587 | 1.587 | $49.2 \%$ | $49.2 \%$ |
| 125 | 0.8 | 0.8 | $49.6 \%$ | $49.6 \%$ |

Table 9: Comparison of the calculated and the measured results of the proposed divider for the input frequency of 10 kHz .

| Division <br> ratio | Calculated <br> $f_{\text {out }}(\mathrm{Hz})$ | Measured <br> $f_{\text {out }}(\mathrm{Hz})$ | Calculated <br> output <br> duty-cycle | Measured <br> output <br> duty-cycle |
| :---: | :---: | :---: | :---: | :---: |
| 10 | 1000 | 1000 | $50.0 \%$ | $50.0 \%$ |
| 15 | 666.7 | 666.7 | $46.7 \%$ | $46.7 \%$ |
| 17 | 588.2 | 588.2 | $47.1 \%$ | $47.1 \%$ |
| 19 | 526.3 | 526.3 | $47.4 \%$ | $47.4 \%$ |
| 24 | 416.7 | 416.7 | $50.0 \%$ | $50.0 \%$ |
| 25 | 400 | 400 | $48.0 \%$ | $48.0 \%$ |
| 33 | 303 | 303 | $48.5 \%$ | $48.5 \%$ |
| 55 | 181.8 | 181.8 | $49.1 \%$ | $49.1 \%$ |
| 65 | 153.8 | 153.8 | $49.2 \%$ | $49.2 \%$ |
| 127 | 78.74 | 78.74 | $49.6 \%$ | $49.6 \%$ |

Table 10: Comparison of the calculated and the measured results of the proposed divider for the input frequency of 1 kHz .

| Division <br> ratio | Calculated <br> $f_{\text {out }}(\mathrm{Hz})$ | Measured <br> $f_{\text {out }}(\mathrm{Hz})$ | Calculated <br> output <br> duty-cycle | Measured <br> output <br> duty-cycle |
| :---: | :---: | :---: | :---: | :---: |
| 11 | 90.91 | 90.91 | $45.5 \%$ | $45.5 \%$ |
| 15 | 66.67 | 66.67 | $46.7 \%$ | $46.7 \%$ |
| 20 | 50 | 50 | $50.0 \%$ | $50.0 \%$ |
| 31 | 32.26 | 32.26 | $48.4 \%$ | $48.4 \%$ |
| 35 | 28.57 | 28.57 | $48.6 \%$ | $48.6 \%$ |
| 39 | 25.64 | 25.64 | $49.7 \%$ | $48.7 \%$ |
| 63 | 15.87 | 15.87 | $49.2 \%$ | $49.2 \%$ |
| 67 | 14.93 | 14.93 | $49.3 \%$ | $49.3 \%$ |
| 81 | 12.35 | 12.35 | $49.4 \%$ | $49.4 \%$ |
| 121 | 8.264 | 8.264 | $49.6 \%$ | $49.6 \%$ |

frequency is in the tens of MHz range, the frequency and the output duty-cycle test results are not very accurate. When the output frequency is lower, such as in kHz or Hz range, the measured results are almost the same as the calculated results.

A number of testing involving temperature, power supply voltage, input signal power and phase noise are also carried out. Figure 35 shows the maximum operating (input) frequency vs. temperature for two chips. For the test related to temperature, the on-chip ring VCO is used as the input source, and with a power supply voltage of 1.8 V . When the temperature increases, the maximum (highest) operating frequency will be decreased. Figure 36 shows the relationship between the highest operating-frequency and the powersupply voltage $\mathrm{V}_{\mathrm{DD}}$ for two chips. If the $\mathrm{V}_{\mathrm{DD}}$ increases, the programmable frequencydivider can operate at higher frequencies. Figure 37 shows the lowest necessary input power vs. the operating frequencies for two chips. When the operating frequency is lower, the divider will be able to operate correctly with smaller power of the input signal.

Figure 38 shows the phase noise measurement of the proposed. Figure 38 (a) shows the input phase noise of the divider. The input signal is a 2.4 GHz signal generated by a signal generator. Figure 38 (b) shows the output phase noise of the proposed divider with the 2.4 GHz input signal generated by the signal generator, and with a division ratio of 240. If Figure 38(a) and (b) are compared, it can be seen that the two phase noise figure has almost the same results. Thus the proposed divider almost adds no phase noise to the circuit.


Figure 35: Maximum operating (input) frequency vs. temperature.


Figure 36: The highest operating (input) frequency vs. $V_{D D}$ for two chips. The dots are the experimental results. The lines are the best-fitting lines.


Figure 37: The lowest necessary input power vs. operating frequencies. The dots are the experimental results. The lines are the best-fitting lines.


Figure 38: The phase noise of the proposed divider: (a) input phase noise of the 2.4 GHz signal generated by the signal generator, and (b) output phase noise of the divider, 2.4 $\mathrm{GHz} / 240=10 \mathrm{MHz}$.

Figure 39 shows the eye diagram measurement [38] of the proposed divider. An Agilent 54624A Oscilloscope is used for the measurement. The on-chip ring VCO is used as the input of the proposed divider, whose output frequency is set to 2.04 GHz . The division ratio of the divider is set to 127 . Figure 39 (a) shows that the zero-crossing jitter of edge 1 $=5.6 \mathrm{~ns}$, and ISI (inter-symbol interference) $=266 \mathrm{mV}$. Figure 39 (b) shows that zerocrossing jitter of edge $2=6 \mathrm{~ns}$, and noise margin $=797 \mathrm{mV}$.

Tests are carried out to check if the proposed divider could change the corner frequency of a SCF. A low pass switched-capacitor filter, MAX7413, is used for the test. The clock signal of the SCF is generated by the proposed divider. The on-chip ring VCO is used as the input of the proposed divider. The output frequency of the VCO is set to about 398 MHz. Figure 40 and Figure 41 show some transient test results of the SCF when the division ratio of the proposed divider is set to 255 and 510 respectively. Channel 1 shows the input signal, and channel 2 shows the output signal. Since the SCF is a low pass filter, when the input frequency is higher, the peak-peak amplitude of the output signal is smaller. For each input frequency, $\mathrm{V}_{\text {out }, \mathrm{p}-\mathrm{p}} / \mathrm{V}_{\text {in, } \mathrm{p} \text { p }}$ is calculated to evaluate the transfer function of the SCF in frequency domain. Figure 42 shows the measurements of the transfer functions of the SCF. The blue dots in Figure 42 show the test results when the division ratio of the proposed divider is 255 . In this case, the output frequency of the divider or the clock frequency of the SCF will be 1.56 MHz . The corner frequency of the SCF (-3DB frequency of the low pass filter) is about 23 kHz . The pink dots in Figure 42 show the test results when the division ratio is doubled, or 510 . In this case, the clock frequency of the SCF is reduced to 780 kHz . The -3 DB frequency of the SCF is about


Figure 39: The eye diagram measurement of the proposed divider: (a) zero-crossing jitter of edge $1=5.6 \mathrm{~ns}$, and $\mathrm{ISI}=266 \mathrm{mV}(\mathrm{b})$ zero-crossing jitter of edge $2=6 \mathrm{~ns}$, and noise margin $=797 \mathrm{mV}$.


Figure 40: Measurements of the proposed divider (division ratio is 255 ) used as the clock signal for a SCF (MAX7413). The input frequencies of the filter are: (a) 1 kHz , (b) 10 kHz , (c) 22 kHz , and (d) 36 kHz .


Figure 41: Measurements of the proposed divider (division ratio is 510) used as the clock signal for a SCF (MAX7413). The input frequencies of the filter are: (a) 1 kHz , (b) 6 kHz , (c) 11 kHz , and (d) 20 kHz .


Figure 42: Measurements of the proposed divider with a SCF.
11.5 kHz . From the test results, the following equation could be obtained,

$$
\begin{equation*}
\frac{23 \mathrm{kHz}}{11.5 \mathrm{kHz}}=\frac{1.56 \mathrm{MHz}}{780 \mathrm{kHz}}=\frac{510}{255} \tag{75}
\end{equation*}
$$

Equation (75) verifies the relationship shown in equation (19). Thus the corner frequency of the SCF is proportional to $f_{\mathrm{clk}}$, which is reversely proportional to the division ratio of the divider.

In general, the test results of the fabricated circuit verify the effectiveness of the proposed programmable divider. It can generate very close-to-50\% output duty-cycle, and with a wide division ratio range for a very wide frequency range ( GHz down to kHz ). The phase noise caused by the proposed divider is also very small.

## Chapter 5

## A Fractional Programmable PLL

### 5.1 Introduction of the Programmable PLL

PLL (Phase Locked Loop) is widely used in telecommunications and computers. It can generate high frequency signals with small phase errors for radio receivers, mobile telephones, GPS systems and computer CPUs. A programmable PLL can generate a range of frequencies from a fixed oscillator. It is more useful since there are more output frequency options.

Figure 43 [39]-[40] shows the block diagram of a typical programmable PLL. A programmable PLL includes the following building block: "Reference Frequency", "PFD (Phase/Frequency Detector) \& Charge Pump", "Loop Filter", "VCO (Voltage-Controlled Oscillator)", and "Programmable Frequency Divider".


Figure 43: The block diagram of a programmable PLL.

In the following statements, all of the phase $\Phi$ is the change compared to the initial $\Phi_{0}$ value. Normally the reference frequency comes from a high quality crystal oscillator. The programmable divider divides the VCO output phase ( $\Phi_{\text {out }}$ ) by N. The "PFD \& Charge Pump" will detect $\Phi_{\text {difference }}$, the difference between $\Phi_{\text {in }}$ and " $\Phi_{\text {out }} / N$ ". It will generate an output current $\mathrm{K}_{\mathrm{PD}} \times \Phi_{\text {difference. }}$. The current will charge or discharge the loop filter and generate a $\mathrm{V}_{\text {control }}$, which is equal to $\mathrm{K}_{\mathrm{PD}} \times \Phi_{\text {difference }} \times \mathrm{Z}(\mathrm{s})$. $\mathrm{Z}(\mathrm{s})$ is the equivalent impedance of the loop filter. The output phase ( $\Phi_{\text {out }}$ ) of the VCO is $\mathrm{V}_{\text {control }} \times \mathrm{K}_{\mathrm{VCO}} / \mathrm{s}$. In reality,

$$
\begin{equation*}
\phi(t)=2 \pi \int f d t=2 \pi f \cdot t \tag{76}
\end{equation*}
$$

Figure 44 shows a detailed schematic of a programmable PLL. It includes a second order loop filter. The following equations could be obtained.

The impedance of the Loop Filter $\mathrm{Z}(\mathrm{s})$ is,

$$
\begin{equation*}
Z(s)=\frac{\left(R_{1}+\frac{1}{s C_{1}}\right) \cdot \frac{1}{s C_{2}}}{R_{1}+\frac{1}{s C_{1}}+\frac{1}{s C_{2}}}=\frac{R_{p} C_{P} s+1}{s\left(C_{p}+C_{2}+s C_{p} C_{2} R_{P}\right)} \tag{77}
\end{equation*}
$$

The open loop gain is,

$$
\begin{equation*}
H(s)_{\text {open }}=\frac{I_{P}}{2 \pi} \cdot \frac{R_{1} C_{1} s+1}{s\left(C_{1}+C_{2}+s C_{1} C_{2} R_{1}\right)} \cdot \frac{K_{V C O}}{s} \cdot \frac{1}{N} \tag{78}
\end{equation*}
$$



Figure 44: More detailed schematic of a programmable PLL.


Figure 45: The bode plot of a programmable PLL.

$$
\begin{equation*}
H(s)_{o p e n}=A \cdot \frac{s-\omega_{z}}{\left(s-\omega_{p 1}\right)\left(s-\omega_{p 2}\right)\left(s-\omega_{p 3}\right)} \tag{79}
\end{equation*}
$$

Figure 45 shows the Bode plot of the open loop gain of a programmable PLL, based on equation (78) and (79). If the two equations are compared, it can be seen that there are: two LHP (left half plane) poles $\left(\omega_{p 1}\right.$ and $\left.\omega_{\mathrm{p} 2}\right)$ at 0 Hz ; one LHP zero $\omega_{\mathrm{z}}$ at $-1 /\left(\mathrm{R}_{1} \mathrm{C}_{1}\right)$; and a third LHP pole $\omega_{p 3}$ at $-1 /\left(\mathrm{R}_{1} \mathrm{C}_{1,2 \text { series }}\right)$, where $\mathrm{C}_{1,2 \text { series }}$ is the equivalent capacitance of $\mathrm{C}_{1}$ and $\mathrm{C}_{2}$ connected in series. Since,

$$
\begin{equation*}
C_{1,2 \text { series }}=\frac{C_{1} C_{2}}{C_{1}+C_{2}}=C_{1} \cdot \frac{C_{2}}{C_{1}+C_{2}}<C_{1} \tag{80}
\end{equation*}
$$

$\omega_{p 3}$ is larger than $\omega_{z}$. The LHP zero will make $s-\omega_{z}=s+\left|\omega_{z}\right|$, which will increase the phase angle of $\mathrm{H}(\mathrm{s})_{\text {open }}$ with larger frequency around frequency $\omega_{z}$. Thus it can improve
the phase margin of $\mathrm{H}(\mathrm{s})_{\text {open }}$ because of the ripple of the $\angle \mathrm{H}_{\text {open }}$ curve shown in Figure 45. When the peak of the ripple happens at the crossover frequency $\omega_{c}$, the best phase margin can be obtained. With a better phase margin, the negative feedback system will be more stable.

Based on Figure 43 and Figure 44, the closed loop transfer function of the programmable PLL could be obtained as follows,

$$
\begin{equation*}
H_{\text {closed }}(s)=\frac{\phi_{\text {out }}}{\phi_{\text {in }}}=\frac{K_{P D} \cdot Z(s) \cdot \frac{K_{V C O}}{s}}{1+\frac{1}{N} \cdot K_{P D} \cdot Z(s) \cdot \frac{K_{V C O}}{s}} \tag{81}
\end{equation*}
$$

By inserting the result of equation (77) into equation (81), the following result will be obtained,

$$
\begin{equation*}
H_{\text {closed }}(s)=\frac{K_{P D} \cdot \frac{R_{1} C_{1} s+1}{s\left(C_{1}+C_{2}+s C_{1} C_{2} R_{1}\right)} \cdot \frac{K_{V C O}}{s}}{1+\frac{1}{N} \cdot K_{P D} \cdot \frac{R_{1} C_{1} s+1}{s\left(C_{1}+C_{2}+s C_{1} C_{2} R_{1}\right)} \cdot \frac{K_{V C O}}{s}} \tag{82}
\end{equation*}
$$

By multiplying $s^{2}$ to both the numerator and the denominator of equation (82), the following result could be obtained,

$$
\begin{aligned}
& H_{\text {closed }}(s)=\frac{K_{P D} \cdot \frac{R_{1} C_{1} s+1}{\left(C_{1}+C_{2}+s C_{1} C_{2} R_{1}\right)} \cdot K_{V C o}}{s^{2}+\frac{1}{N} \cdot K_{P D} \cdot \frac{R_{1} C_{1} s+1}{\left(C_{1}+C_{2}+s C_{1} C_{2} R_{1}\right)} \cdot K_{V C O}} \quad s=j 2 \pi f=0 \text {, } \\
& \text { In equation (83), when }
\end{aligned}
$$

$\mathrm{H}_{\text {closed }}(\mathrm{s})$ will be N . This means that at DC or steady state, the output phase $\Phi_{\text {out }}=\mathrm{N} \times$ $\Phi_{\text {in }}$. According to equation (76), $\Phi \propto f$, so $f_{\text {out }}=\mathrm{N} \times f_{\text {in }}$.

### 5.2 A Fractional Programmable PLL

A frequency divider is an important component in a PLL. If the division ratio is N , and the input reference frequency of a PLL is $f_{\text {in }}$, the output frequency $f_{\mathrm{o}}$ will be $\mathrm{N} \cdot f_{\text {in }}$. In the case of a PLL using a programmable divider, the frequency channel-distance of $f_{0}$ will be $\Delta \mathrm{N} \cdot f_{\text {in }}$, where $\Delta \mathrm{N}$ is the increasing step of the division ratios. Obviously, the smaller the value of $\Delta \mathrm{N}$, the smaller is the channel distance. With a smaller channel distance and limited entire bandwidth, there could be more channels. It is not always a good idea to reduce $f_{\text {in }}$, because it will make a PFD to wait longer to compare the reference frequency with the signal out of the frequency divider. In that case, a longer settling time will be induced to the PLL. If a fractional programmable divider is used, $\Delta \mathrm{N}$ will be reduced. Without decreasing $f_{\text {in }}$, smaller channel distance still could be obtained. Since $f_{\text {in }}$ is not reduced, the settling time of the PLL will not be longer.

Another advantage of fractional division ratios is stated bellow. The loop bandwidth of a PLL should be set to lower than $1 / 10$ of the reference frequency. At higher offset frequencies, the VCO phase noise will be smaller. Since the VCO phase noise will be high-passed to the output of the PLL, the VCO phase noise will be suppressed more with a wider loop bandwidth or a higher reference frequency. Thus with the same frequency resolution or output frequency channel distance, a fractional divider can use a higher reference frequency, which can have a wider loop bandwidth and lower phase noise from the VCO [30] [31].

### 5.2.1 A Fractional Programmable Frequency Divider

Figure 46 shows the schematic of the proposed fractional programmable PLL. The difference between this PLL and the one shown in Figure 43 is that a Delta-Sigma $(\Delta \Sigma)$ modulator is added to control the division ratio of the integer divider. The output signal of the $\Delta \sum$ modulator is changing between " 0 " and " 1 ". For the $\Delta \sum$ modulator, if the fractional number at the input is ". f ", the time percentage when the output is " 1 " should also be ". f ". The average value of the output of the $\Delta \sum$ modulator will be ". f ". Thus the LSB division ratio control $P_{0}$ will have an average value of ". f ". If use " m " to represent the binary combination of the MSB controls " $\mathrm{P}_{1} \mathrm{P}_{2} \ldots \mathrm{P}_{\mathrm{n}}$ ", the entire division ratio will be "m.f". A fractional programmable division ratio is obtained and the output frequency $f_{\text {o }}$ will be " $\mathrm{m} . \mathrm{f} \times f_{\text {in }}$ ".

Figure 47 shows the schematic and the equivalent model of a first order $\Delta \sum$ modulator. It is an accumulator as shown at the left part of Figure 47, which includes a multi-bit adder and several DFFs.

If $\omega T \ll 1$, and $T$ is the clock period for the accumulator,

$$
\begin{gather*}
z^{-1}=e^{-s T}=e^{-j \omega T}=\cos (\omega T)-j \sin (\omega T) \approx 1-j \omega T=1-s T  \tag{84}\\
\therefore 1-z^{-1}=1-(1-s T)=s T \tag{85}
\end{gather*}
$$

From the equations shown in Figure 47 and equations (84) and (85), the following results could be obtained,


Figure 46: Schematic of the proposed fractional programmable PLL.


Figure 47: Schematic and the equivalent model of a first order $\Delta \sum$ modulator.

$$
\begin{equation*}
Y=F+E \cdot\left(1-z^{-1}\right) \approx F+E \cdot s T=F+E \cdot j 2 \pi f \tag{86}
\end{equation*}
$$

According to the result in equation (86), the output Y of the accumulator will high pass the quantization error E . It means that when the frequency $f$ is higher, the output Y will contain larger component coming from the quantization error E . Thus the phase noise of Y will be higher at higher frequency $f$.

Figure 48 shows the proposed fractional programmable divider with more details. An accumulator or a $\Delta \Sigma$ modulator is inserted between the " $f_{\text {out origin }}$ " and the " $\mathrm{C}_{\text {in }}$ " input of the adder. The inputs of the accumulator are part of the division ratio controls. " $\mathrm{S}_{0}$ " is the LSB integer ratio control, while " $\mathrm{Sf}_{1}$ " and " $\mathrm{Sf}_{2}$ " are the MSB and LSB binary controls of the fractional division ratio. The input clock signal of the accumulator is connected to the original (Figure 7 (b)) integer divider output.

When the division ratio is $<2^{\min +1}$, $\mathrm{S}_{\min }$ is set to logic ' 1 '. Thus the division ratio of the fractional divider will be,
division ratio

$$
\begin{equation*}
=S f_{2} \cdot 2^{-2}+S f_{1} \cdot 2^{-1}+S_{0}+S_{1} \cdot 2^{1}+S_{2} \cdot 2^{2}+S_{3} \cdot 2^{3}+\cdots+S_{n-1} \cdot 2^{n-1}+S_{n} \cdot 2^{n} \tag{87}
\end{equation*}
$$

### 5.2.2 The LC VCO

Figure 49 shows the LC VCO used in the proposed PLL, which is similar to the circuit used in [41]. Figure 49 (a) shows the top level schematic, (b) shows the equivalent circuit of the LC tank, and (c) shows the equivalent one-side circuit. The advantage of this circuit is the low power consumption and not too large output swing.


Figure 48: Schematic of the proposed fractional programmable frequency divider with more details.

(a)

(c)

Figure 49: Schematic of the LC VCO used in the PLL: (a) the top level schematic, (b) the equivalent circuit of the LC tank, and (c) the equivalent one-side circuit.

In Figure 49 (a), both PMOS and NMOS cross-coupled pairs exist. They can reduce the power consumption, and limit the output swing to avoid destroying any device in the circuit. " $\mathrm{R}_{\mathrm{L}}$ " is the series resistance of the inductor. The output impedance at the drain of each cross-coupled MOS is $-2 / \mathrm{g}_{\mathrm{m}}$ [39]. The VCO control voltage $\mathrm{V}_{\text {control }}$ and the voltage at the middle point of the inductor should be constant at the steady state. Thus they are AC ground. By splitting the inductor into two equal parts, Figure 49 (b) could be obtained. The left and right parts of Figure 49 (b) have symmetric structures. Forsimplicity, Figure 49 (c) only shows the left side of Figure 49 (b). In Figure 49 (c), according to [40],

$$
\begin{equation*}
R_{L P}=R_{L}\left(Q^{2}+1\right), \text { and } L_{P}=L \frac{Q^{2}+1}{Q^{2}} \approx L \tag{88}
\end{equation*}
$$

To keep the LC tank oscillate, the parallel impedance of $-2 /\left(g_{m p}+g_{m n}\right)$ and $R_{L P}$ should be infinite, so the current flowing into them will be 0 with limited voltage cross them. In that case, "-2 / ( $\left.g_{m p}+g_{m n}\right)$ and $R_{L P} "$ could be viewed as open circuit and be excluded from the LC tank. Thus the LC tank could maintain the oscillation like an ideal one. The following relationship should exist,

$$
\begin{gather*}
\frac{-\frac{2}{g_{m p}+g_{m n}} \cdot R_{L P}}{-\frac{2}{g_{m p}+g_{m n}}+R_{L P}}=\infty \Rightarrow-\frac{2}{g_{m p}+g_{m n}}+R_{L P}=0  \tag{89}\\
\therefore R_{L P}=\frac{2}{g_{m p}+g_{m n}} \tag{90}
\end{gather*}
$$

$$
\begin{equation*}
\therefore g_{m p}+g_{m n}=\frac{2}{R_{L P}} \tag{91}
\end{equation*}
$$

Since $g_{m}=\sqrt{2 \beta I}$, sufficient large current " $I$ " has to be given in the circuit for sufficient large $g_{m p}+g_{m n}$. Here $g_{m p}$ and $g_{m n}$ use the same dc current. There are other types of LC VCOs [37], which only have one pair of cross-coupled MOS, such as only one pair of cross-coupled NMOS. After the derivation similar to the above, the following relationship will be obtained,

$$
\begin{equation*}
g_{m n}=2 / R_{L P} \tag{92}
\end{equation*}
$$

Only one item $\mathrm{g}_{\mathrm{mn}}$ appears on the left part of the equation. Thus for the same value of $\mathrm{R}_{\mathrm{LP}}$, more current is needed to obtain larger $\mathrm{g}_{\mathrm{mn}}$, when compared with equation (91).

Another advantage of the VCO shown in Figure 49 (a) is that the output voltage will not be higher than $V_{D D}$. While for some other types of LC VCO [37], the output may be higher than $V_{D D}$, which may destroy some transistors connected to the VCO outputs. In Figure 49 (a), when "Out ${ }_{p}$ " is high, "Out ${ }_{n}$ " should be low. Thus $\mathrm{M}_{4}$ is off and $\mathrm{M}_{3}$ is on. When "Out ${ }_{p}$ " is increased closed to $\mathrm{V}_{\mathrm{DD}}, \mathrm{M}_{3}$ enters the linear region. The drain current of $M_{3}$ will be reduced. When "Out ${ }_{p}$ " is increased to $V_{D D}$, the drain current of $M_{3}$ will be 0 . Thus the highest voltage of "Out ${ }_{p}$ " will be $V_{D D}$. Similarly, the highest voltage of "Out ${ }_{n}$ " will also be $\mathrm{V}_{\mathrm{DD}}$. Using this VCO , the circuit can operate properly for a long time.


Figure 50: Schematic of the active loop filter.

### 5.2.3 The Loop Filter

Figure 50 shows the schematic of the active loop filter used in the proposed PLL. An offchip amplifier is used in the proposed active loop filter. The advantage of this circuit is that the voltage at the inverting input of the amplifier will be biased at $\mathrm{V}_{\mathrm{DD}} / 2$. Thus the voltage of the charge pump output will also be biased at $\mathrm{V}_{\mathrm{DD}} / 2$.

The charge pump is shown in Figure 44. The current sources are MOS transistors in current mirrors. If the charge pump output is much lower than $\mathrm{V}_{\mathrm{DD}} / 2$, and the switch connected to the NMOS current source is closed. The drain of the NMOS transistor used as the current source will also be much lower than $\mathrm{V}_{\mathrm{DD}} / 2$. Since the $\mathrm{V}_{\mathrm{DS}}$ may be less than $\mathrm{V}_{\mathrm{GS}}-\mathrm{V}_{\mathrm{thN}}$, the NMOS transistor may be driven into linear region. Thus the current generated from the NMOS current source will be smaller than the ideal value. At the same time, if the switch connected to the PMOS transistor used as the current source is closed, the drain of the PMOS transistor will be much lower than $\mathrm{V}_{\mathrm{DD}} / 2$. Since the $\mathrm{V}_{\mathrm{SD}}$ will be larger than $\mathrm{V}_{\mathrm{SG}}-\left|\mathrm{V}_{\text {thp }}\right|$, the PMOS transistor will be in the saturation region. Its current will be the same as the ideal value. Thus there is a mismatch between the NMOS
and PMOS current sources. If the charge pump output is much higher than $\mathrm{V}_{\mathrm{DD}} / 2$, the mismatch also exists. The current mismatch will induce jitters at the output signal of the PLL [37].

With the same combination of $R_{1}, C_{1}$ and $C_{2}$, their equivalent impedance $Z(s)$ in Figure 50 will be the same as the $Z(s)$ shown in equation (77). Since $V_{D D} / 2$ is a constant value, the inverting input of the amplifier could be viewed as AC ground. Thus from Figure 50, the following result could be obtained,

$$
\begin{equation*}
V_{\text {control }}=-I_{p} \times Z(s) \tag{93}
\end{equation*}
$$

For the passive loop filter shown in Figure 44,

$$
\begin{equation*}
\mathrm{V}_{\text {control }}=\mathrm{I}_{\mathrm{p}} \times \mathrm{Z}(\mathrm{~s}) \tag{94}
\end{equation*}
$$

With the comparison of equations (93) and (94), the active loop filter has similar effects in the circuit as the passive loop filter. The only difference between them is that the polarities in equations (93) and (94) are different.

### 5.2.4 Test Results

The fractional programmable PLL is fabricated in the same chip using a standard 0.18$\mu \mathrm{m}$ CMOS process. The right part of Figure 28 shows the photograph of the proposed PLL after fabrication.

Figure 51 shows the output spectra of the proposed PLL, where the divider in the PLL has division ratios of (a) 240 (b) 240.25 . Figure 52 shows the phase-noise measurements
of the proposed PLL, where the divider in the PLL has division ratios of (a) 240 (b) 240.25 (c) 240.5 (d) 176.25 . Both the output spectra and the phase-noise plot show the PLL output power densities at different frequencies. The phase-noise plot has a log-scale frequency unit, which is the difference from the output spectra. A $2^{\text {nd }}$ order active loop filter is used in the PLL. The loop bandwidth of the PLL is set to about 100 kHz . The experimental results show about $-82 \mathrm{dBc} / \mathrm{Hz}$ in-band phase noise at 10 kHz -offset frequency and $-135 \mathrm{dBc} / \mathrm{Hz}$ out-of-band phase noise at 100 MHz -offset frequency. The jitter at the reference frequency $(10 \mathrm{MHz}$ ) is about $-67 \mathrm{dBc} / \mathrm{Hz}$ compared with the PLL (or VCO ) output power at the carrier frequency.


Figure 51: Output spectra of the proposed fractional programmable PLL. The divider in the PLL has division ratios of: (a) 240, and (b) 240.25.


Figure 52: Phase-noise test results of the proposed fractional programmable PLL. The divider in the PLL has division ratios of: (a) 240, (b) 240.25, (c) 240.5 , and (d) 176.25.

The fractional programmable PLL has an approximate frequency range of $1.7-2.5 \mathrm{GHz}$, and a frequency resolution of 2.5 MHz . With a 1.8 volt power supply, the power consumption is about 20 mW . The PLL can operate at 2.4 GHz with a power consumption of only 10 mW with a 1.46 V power supply voltage.

## Chapter 6

## Conclusions and Future Work

A highly efficient programmable frequency-divider with a wide division ratio range and close-to-50\% output duty-cycle has been presented. The circuits are designed and fabricated using a $0.18-\mu \mathrm{m}$ RF CMOS process. The test results verify the effectiveness of the proposed design. The output duty-cycle does not change with the input frequency (3.5 GHz down to 1 kHz ), with temperature, with the voltage supply, or with different chips. When the power supply is 1.8 V , the power consumption of the programmable frequency-divider is about 15 mW .

A fractional programmable PLL is also presented. Test results show that the proposed PLL has a frequency resolution of 2.5 MHz , and a minimum power consumption of 10 mW when operating at 2.4 GHz .

In the future, a fractional PLL with a multi-bit and higher order $\Delta \sum$ modulator can be implemented for finer frequency resolution and lower phase noise. A charge pump [42] shown in Figure 53 can be implemented in the PLL. It can reduce jitters of the PLL at the reference frequency.

The charge pump shown in Figure 44 has a charge-sharing problem, which is stated in section 15.3.1 of [37]. This problem occurs when the PFD compares the reference


Figure 53: A charge pump that can reduce jitters at the reference frequency.
frequency and the divider output. Thus PLL output jitters will appear at the reference frequency. The advantage of the charge pump shown in Figure 53 is stated as follows. $\mathrm{M}_{5}$ and $M_{6}$ have the same size. $M_{3}$ and $M_{4}$ have the same size. When UP is high, $M_{6}$ is on and $\mathrm{M}_{5}$ is off. When UP changes from high to low, $\mathrm{M}_{6}$ turns off and $\mathrm{M}_{5}$ turns on. $\mathrm{V}_{\mathrm{y}}$ follows $\mathrm{V}_{\text {control }}$ and is equal to $\mathrm{V}_{\text {control }}$. When UP changes from low back to high, $\mathrm{M}_{6}$ turns on and $M_{5}$ turns off. Since $M_{5}$ and $M_{6}$ have the same size, and $V_{y}$ is equal to $V_{\text {control }}$, neither $\mathrm{I}_{\mathrm{d} 7}$ nor $\mathrm{V}_{\mathrm{x}}\left(\mathrm{V}_{\mathrm{D} 7}\right)$ will change. Thus the charges on $\mathrm{C}_{\mathrm{DB} 7}$ and $\mathrm{C}_{\mathrm{GD} 7}$ will not change. Since $\mathrm{I}_{\mathrm{D} 8}$ and $\mathrm{V}_{\mathrm{SG} 7}$ are constant, $\mathrm{V}_{\mathrm{G} 7}$ is ac ground. There is no current flowing into $\mathrm{C}_{\mathrm{DB} 7}$ and $\mathrm{C}_{\mathrm{GD} 7}$. Thus the current flowing into the loop filter will be exactly $\mathrm{I}_{\mathrm{p}}$. For DOWN part, when DOWN changes from low to high, $\mathrm{V}_{\mathrm{Z}}\left(\mathrm{V}_{\mathrm{D} 1}\right)$ and the charges on $\mathrm{C}_{\mathrm{DB} 1}$ and $\mathrm{C}_{\mathrm{GD} 1}$ also do not change. Thus the current flowing out of the loop filter will be exactly $\mathrm{I}_{\mathrm{p}}$. No (or very little) current or charging disturbance occurs. Thus the PLL output jitters at the reference frequency will be reduced.

Programmable frequency divider is an important component in the integrated high-speed circuit. Any improvements of it will benefit in RF and digital design area. A programmable PLL is also a very interesting and challenging work. Efforts to improve each block in it will enhance the performance of the PLL, which may result more applications.

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#### Abstract

Vita

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